

MICROCAVITY PLASMA SCIENCE AND RECENT APPLICATIONS: BOUND-FREE COUPLING, TRANSISTORS AND ILLUMINATION

J. Gary Eden

Laboratory for Optical Physics and Engineering
Department of Electrical and Computer Engineering
University of Illinois
Urbana, IL USA



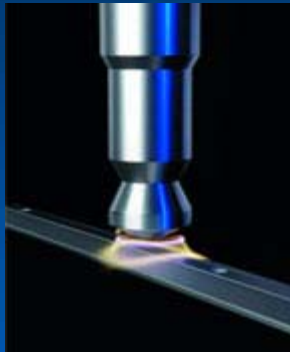
Gas Laser



Ozone generator



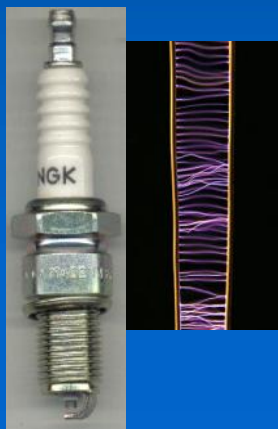
High Intensity
Plasma Arc Lamp



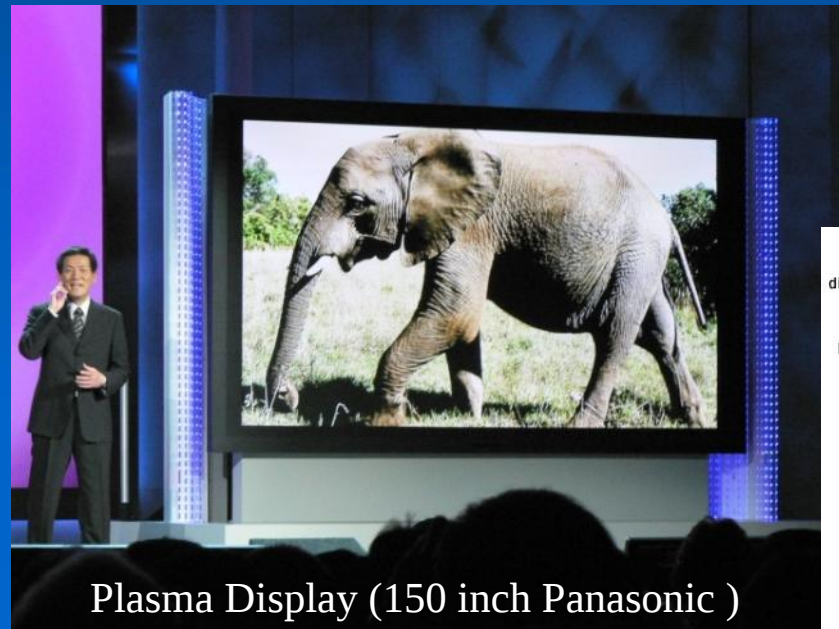
Plasma Surface Treatment



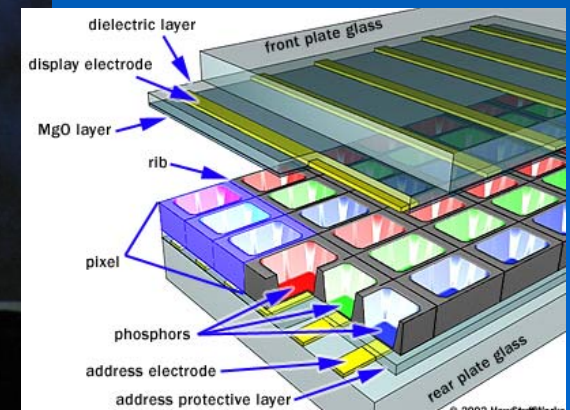
Fluorescent Lamp



Spark Gap

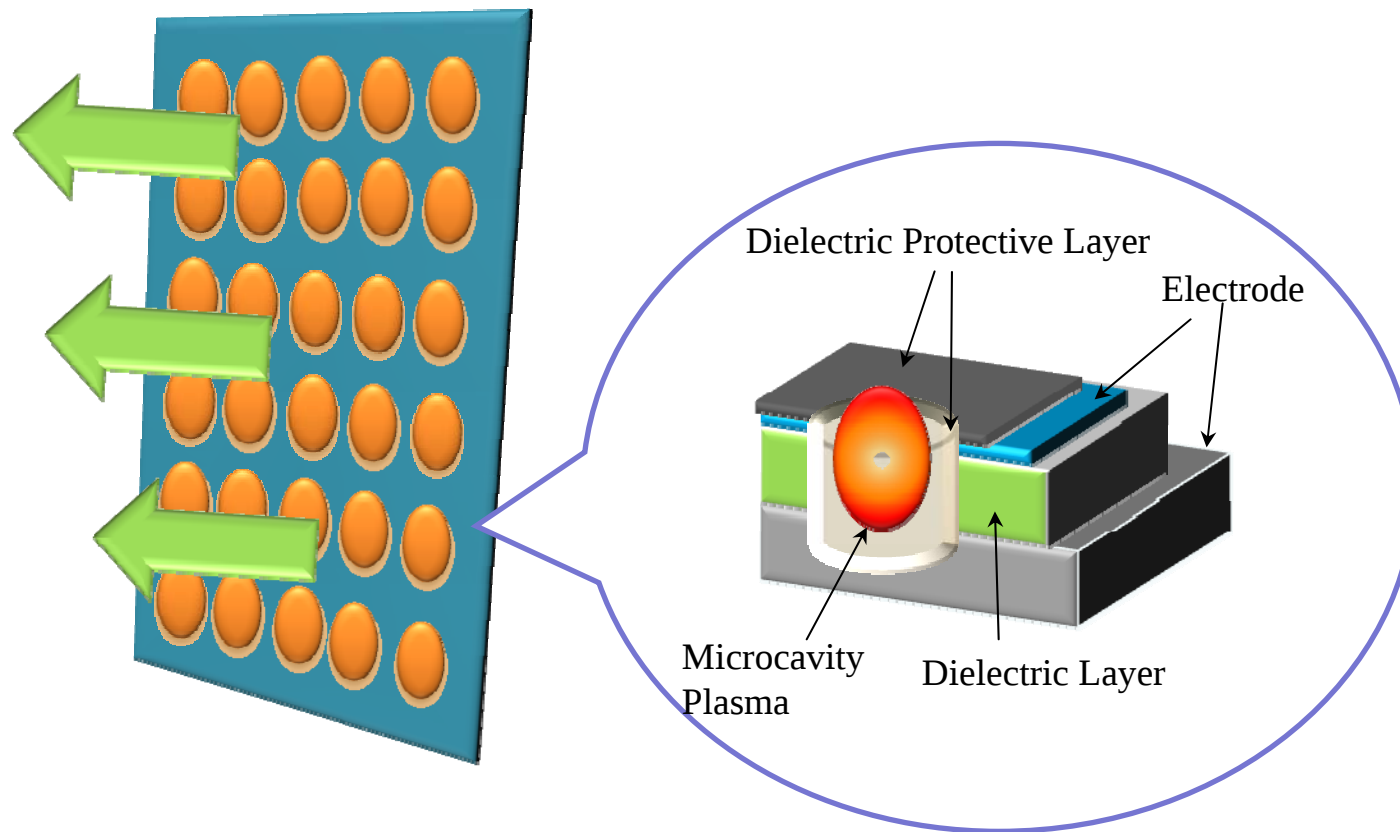


Plasma Display (150 inch Panasonic)





MICROCAVITY PLASMAS: LOW TEMPERATURE, NONEQUILIBRIUM PLASMA CONFINED TO MESOSCOPIC CAVITIES



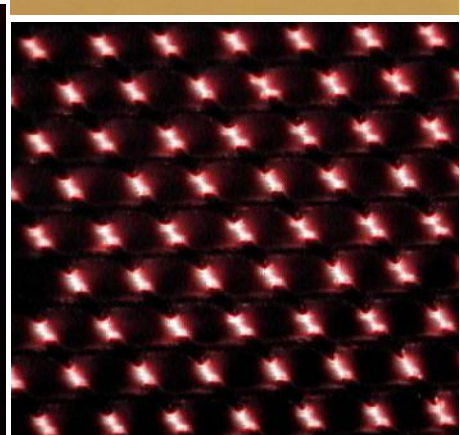
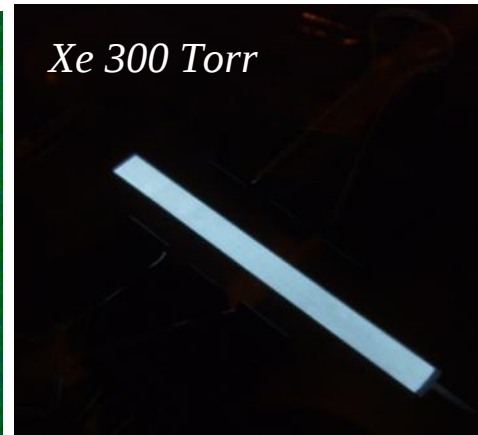
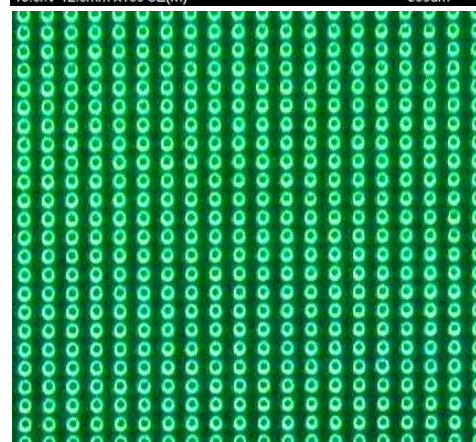
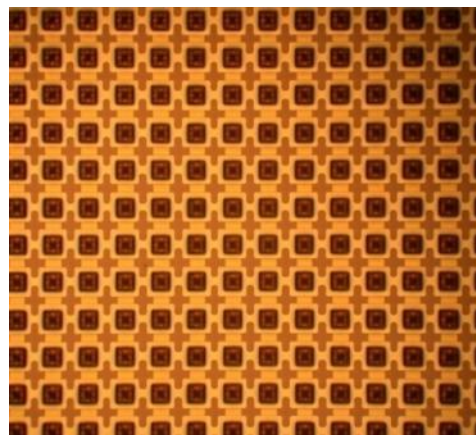
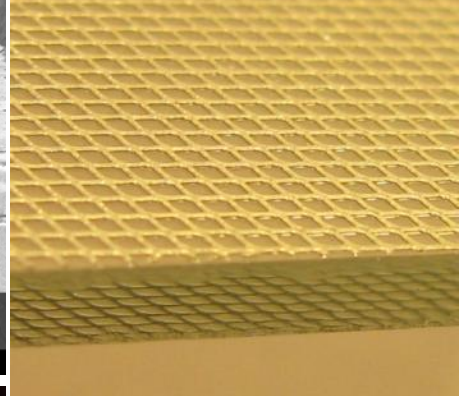
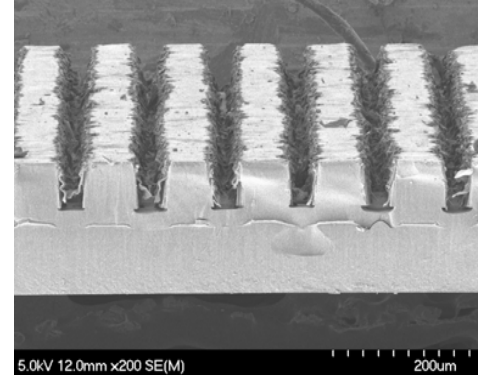
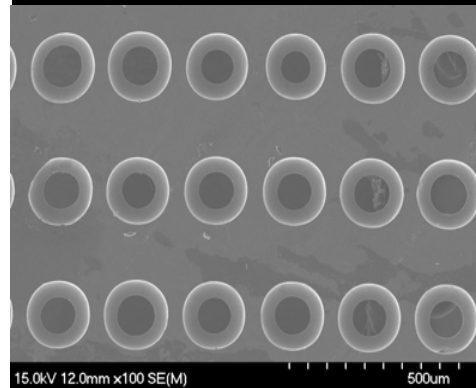
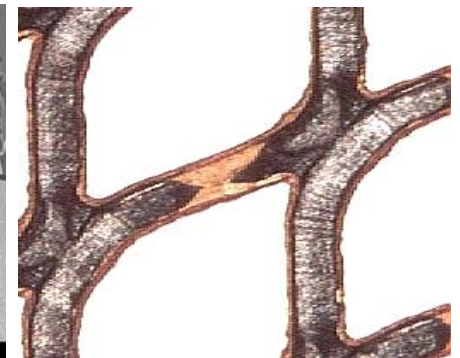
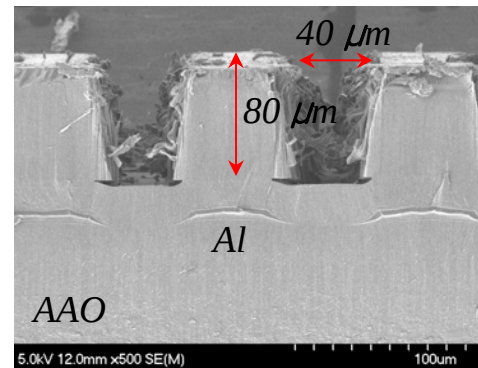
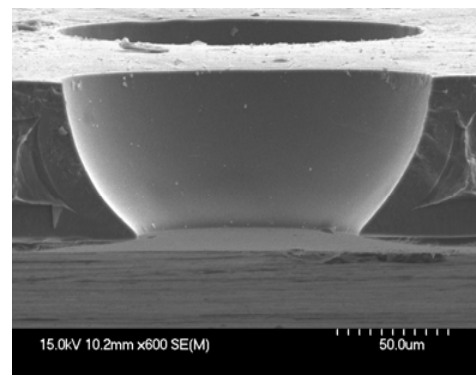
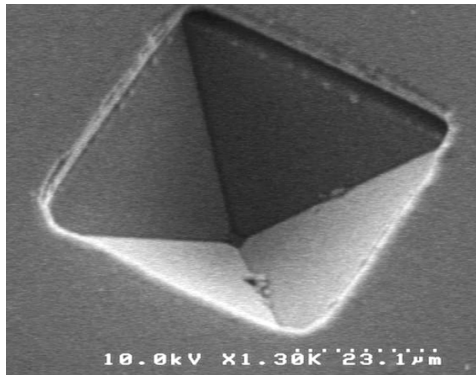


KEY CHARACTERISTICS

- Glow discharges confined to mesoscopic dimensions ($< 10 \sim 100 \mu\text{m}$)
- Microcavity volumes: nanoliters $\rightarrow$ picoliters
- A variety of atomic and molecular emitters are available (VUV $\sim$ IR)
- Can be operated continuously at gas pressures beyond one atmosphere at power loadings exceeding 100 kW/cm^3
- Ability to interface plasma in gas or vapor phase with $e\text{-}h^+$ plasma in a semiconductor
- Precise control of microcavity geometry

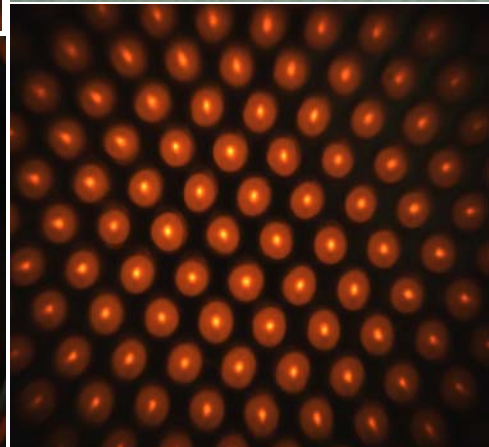
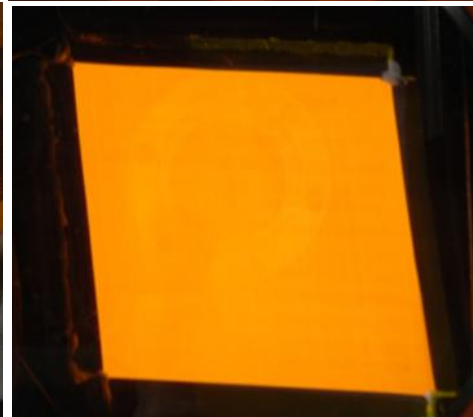
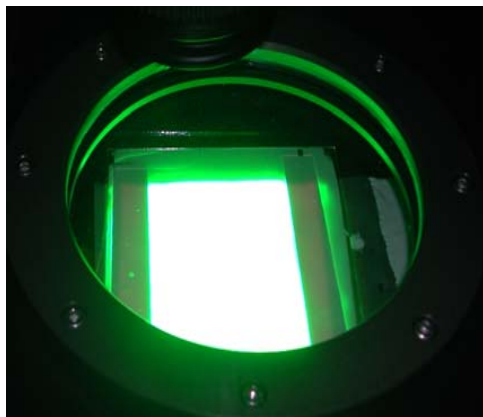
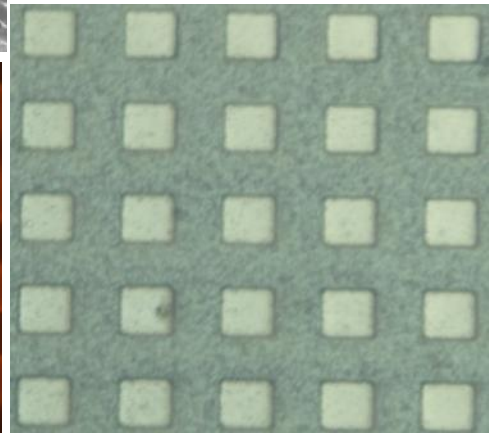
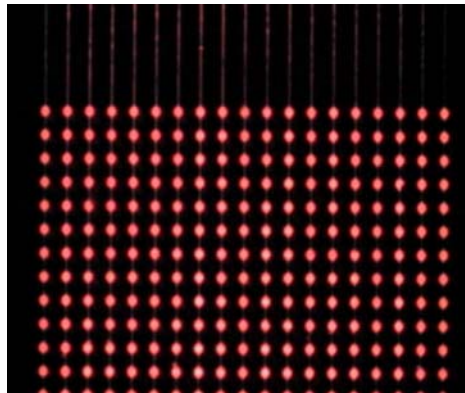
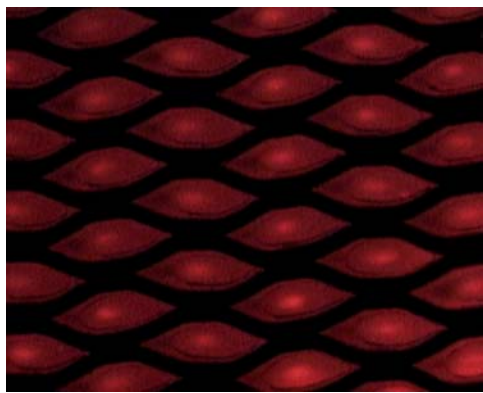
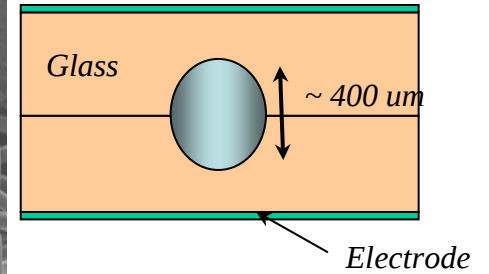
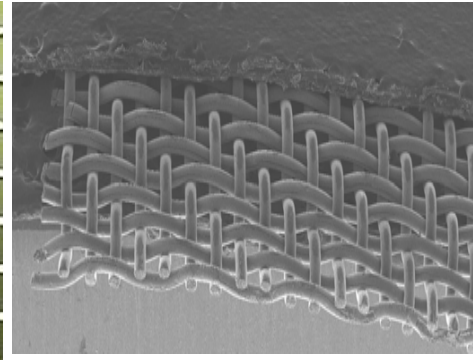
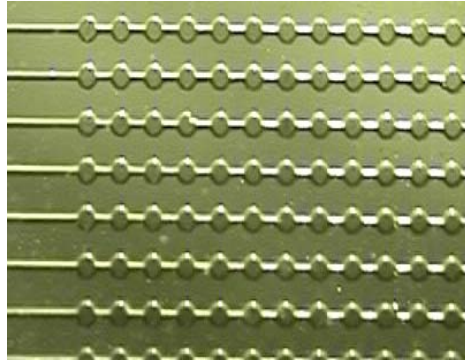
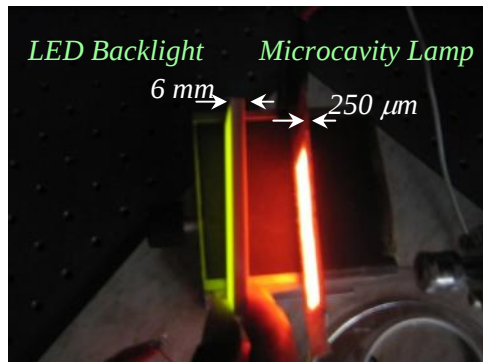


Microplasma Arrays at Illinois





Microplasma Arrays at Illinois



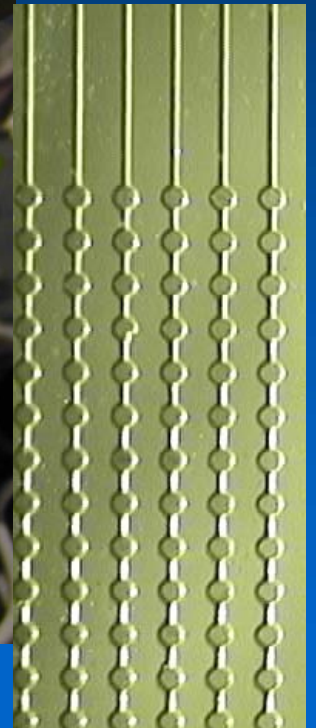
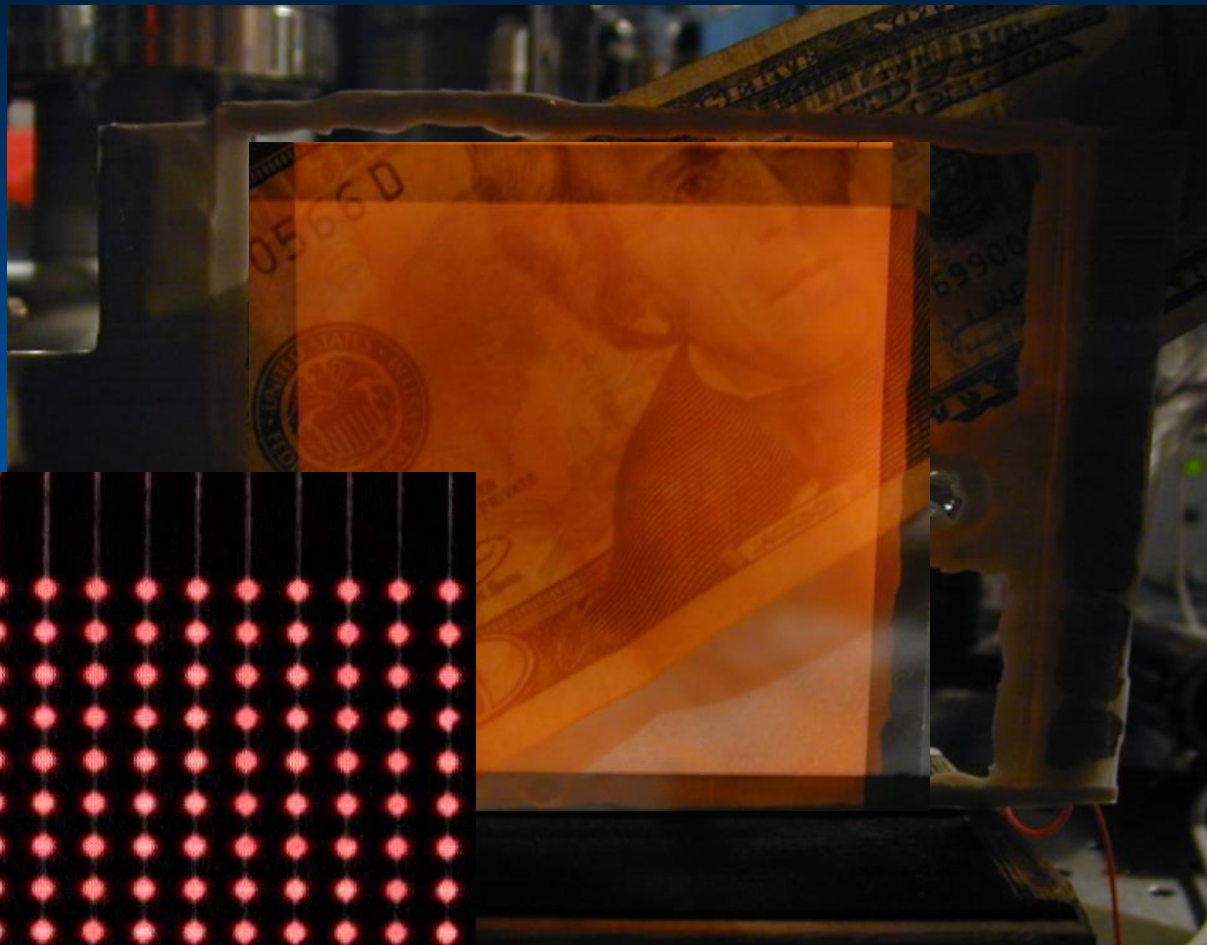


OPERATION OF MICROCAVITY PLASMA DEVICES IN ATMOSPHERIC AIR



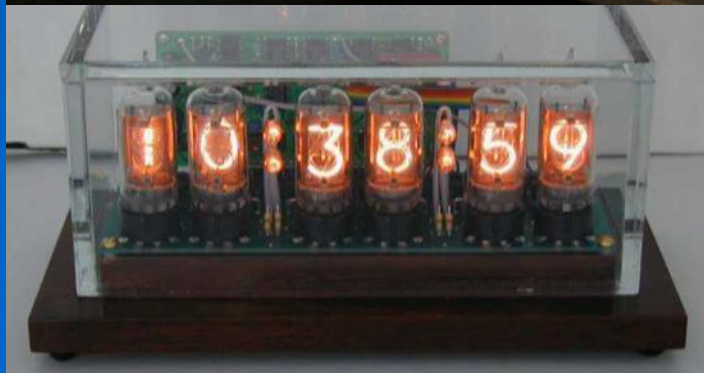
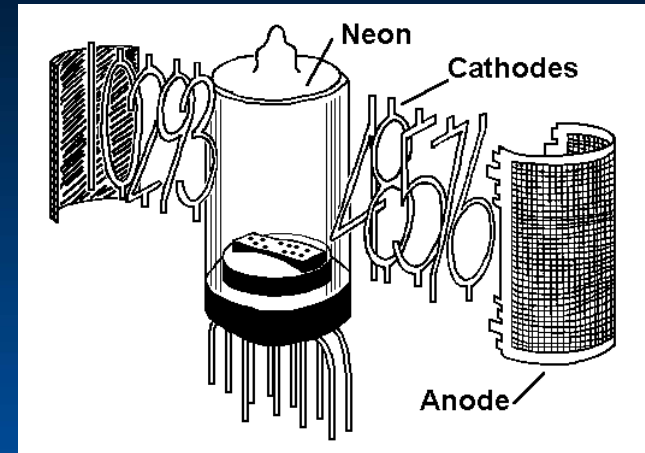


FULLY TRANSPARENT 250 × 250 MICROCAVITY ARRAY



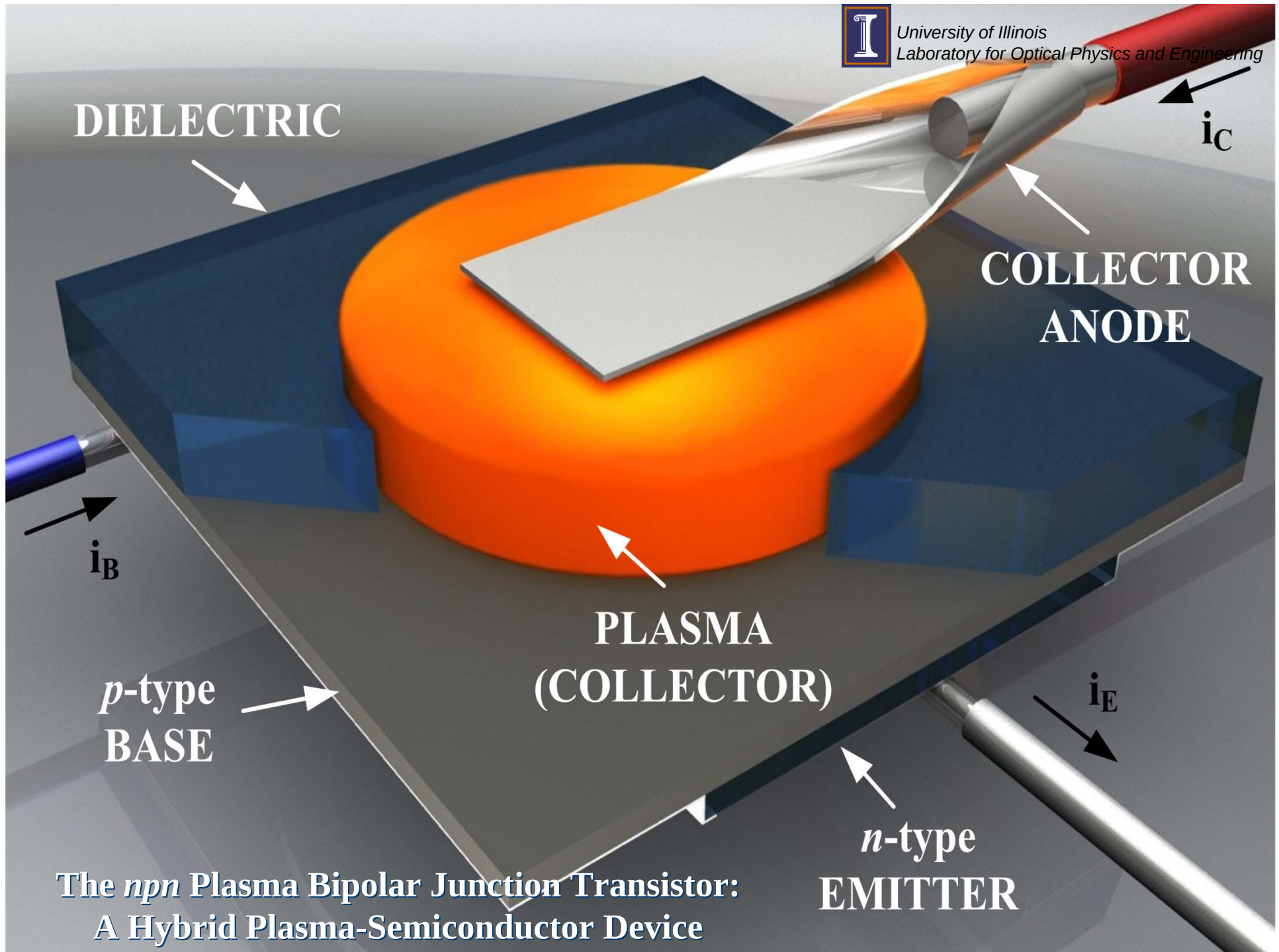


PLASMA ELECTRONICS/PHOTONICS: NIXIE TUBES

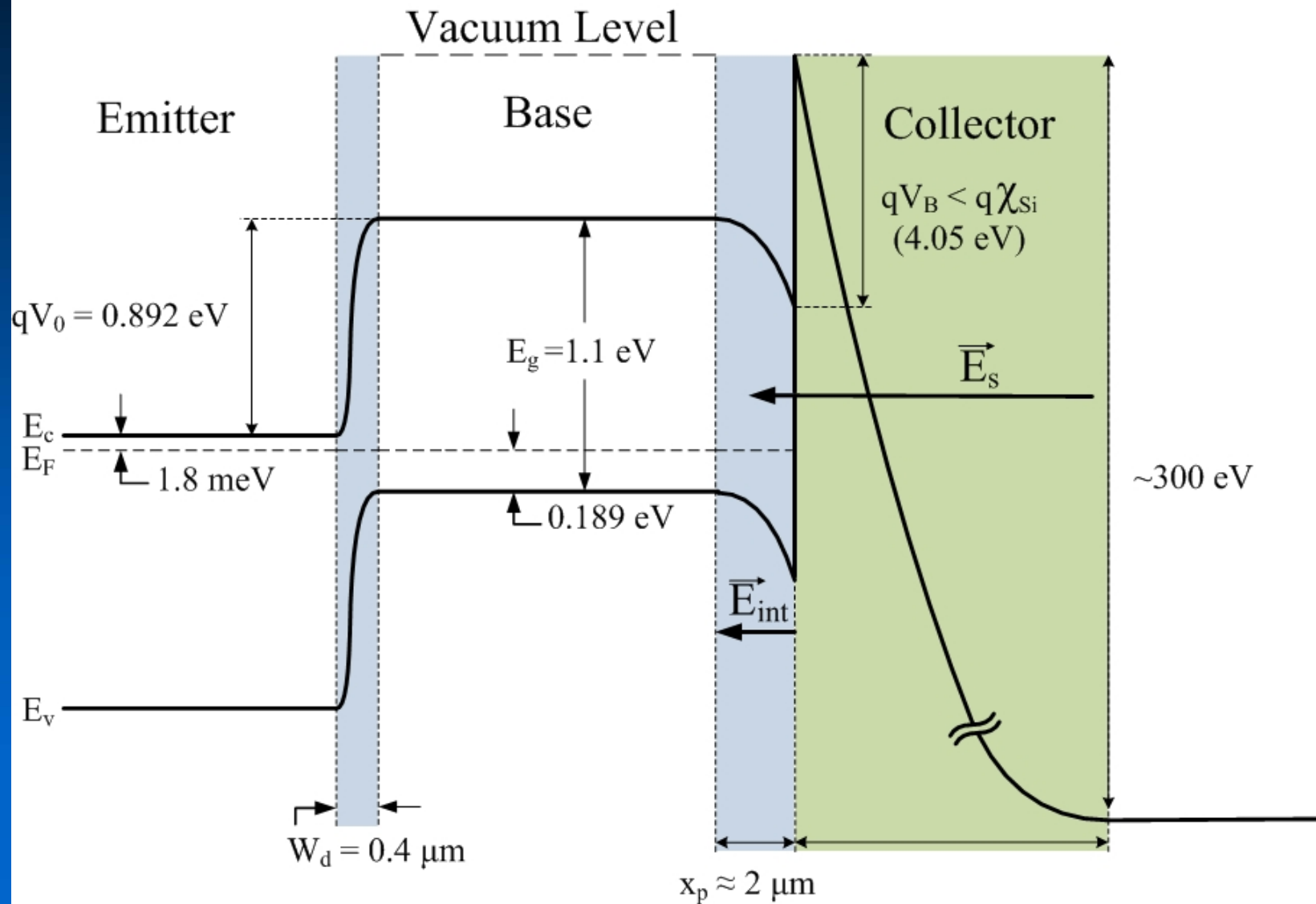


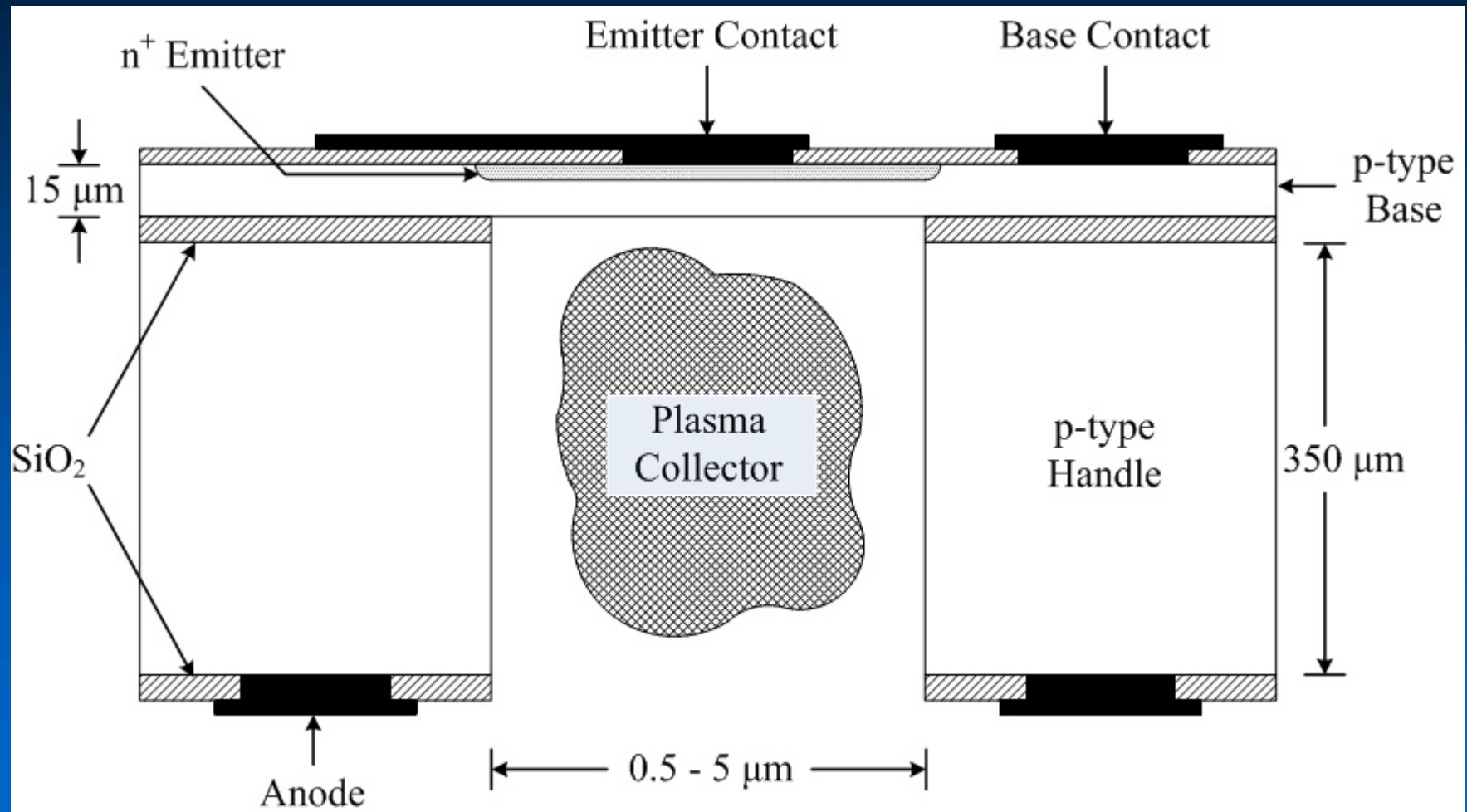


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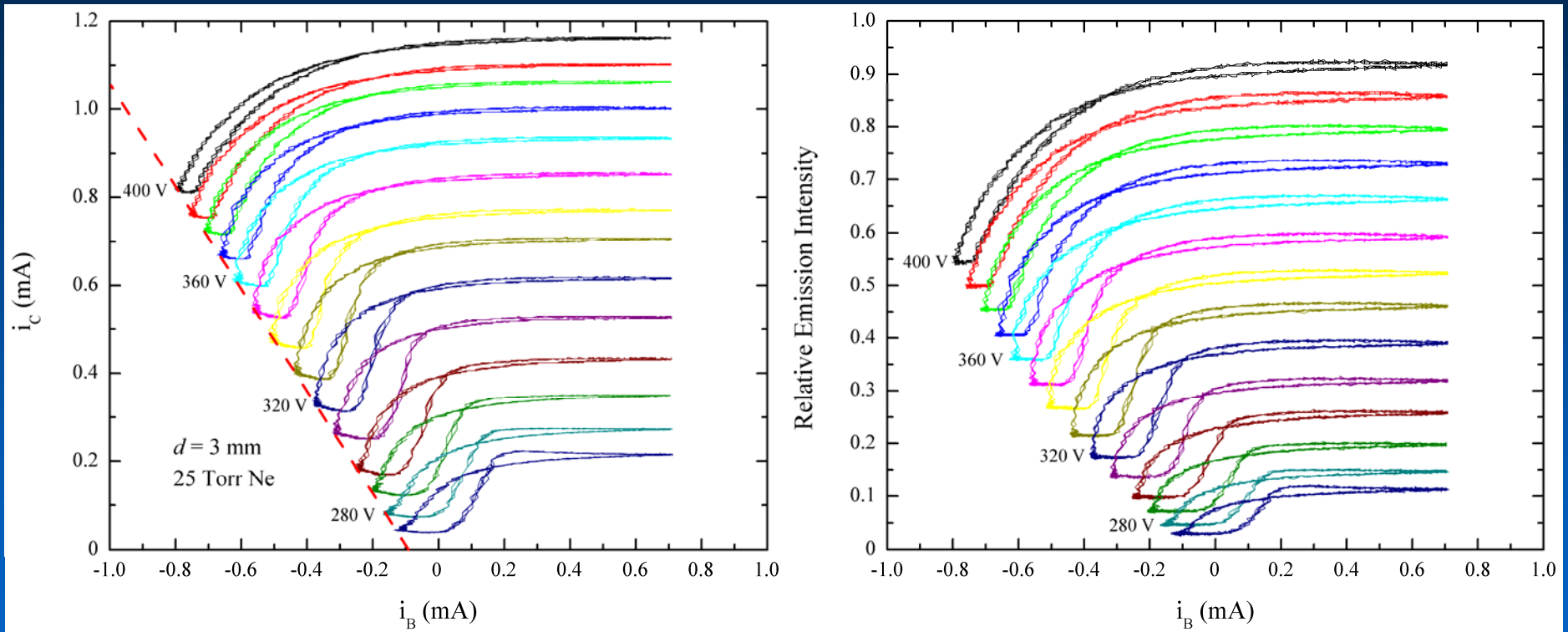
The *n*pn Plasma Bipolar Junction Transistor:
A Hybrid Plasma-Semiconductor Device







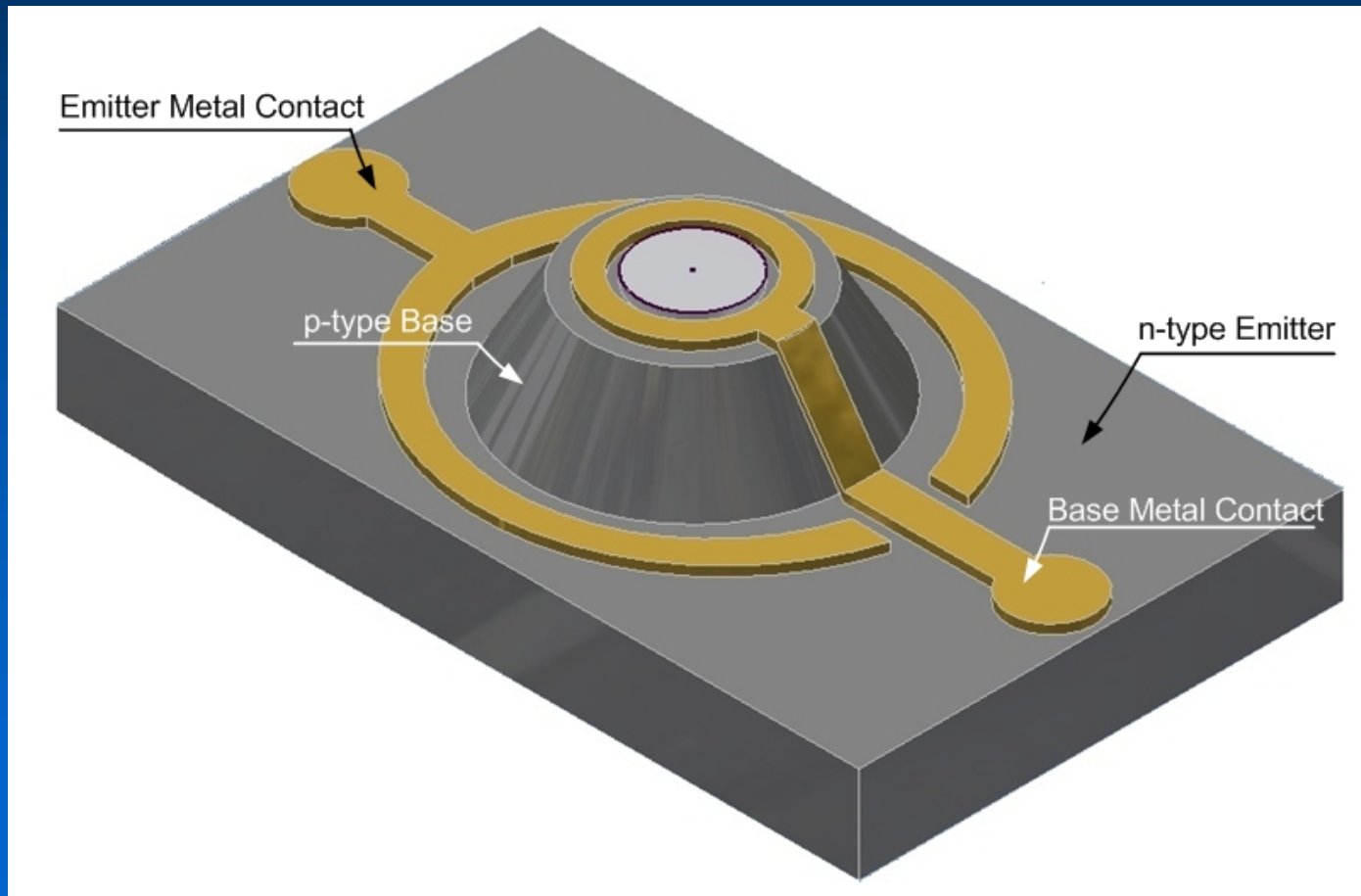
BASE-COLLECTOR CHARACTERISTICS



25 Torr Ne

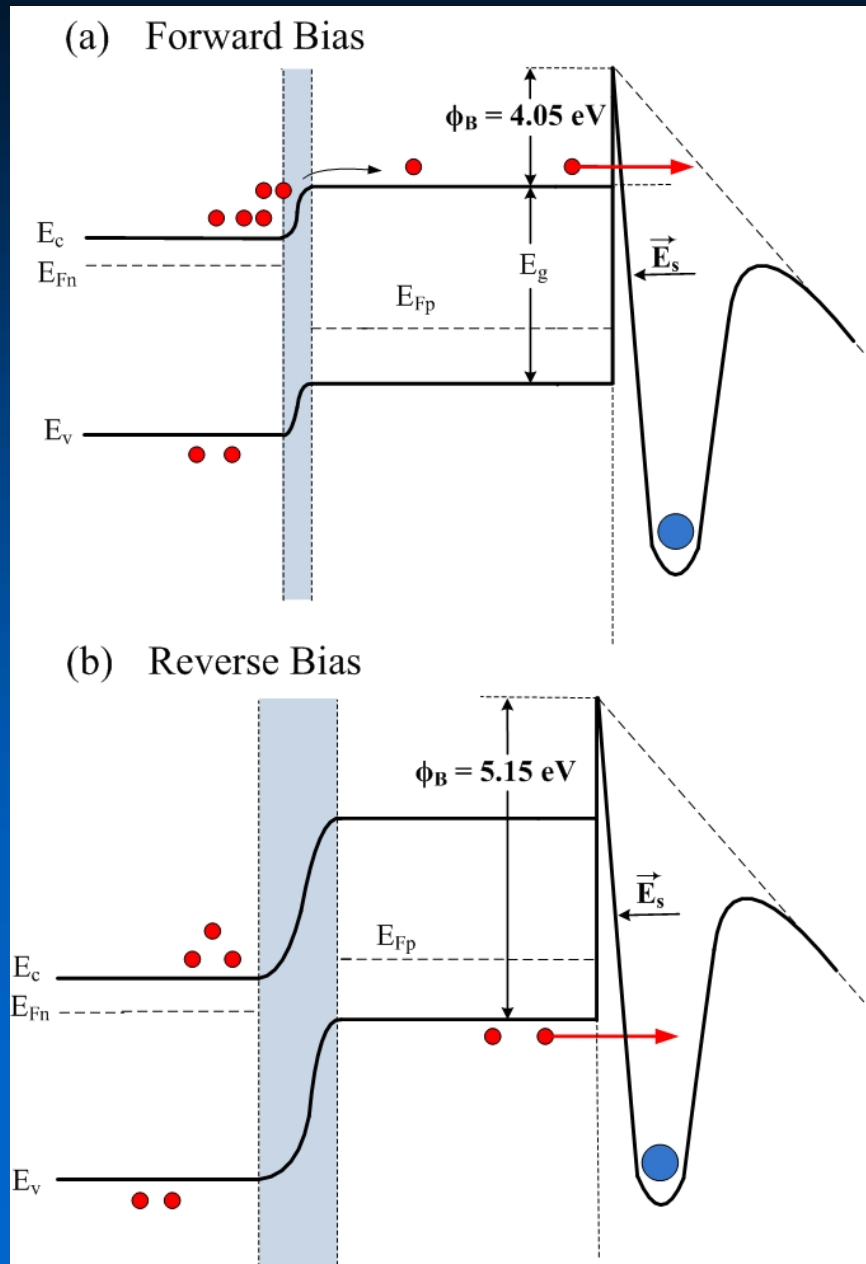


MESA DEVICE STRUCTURE





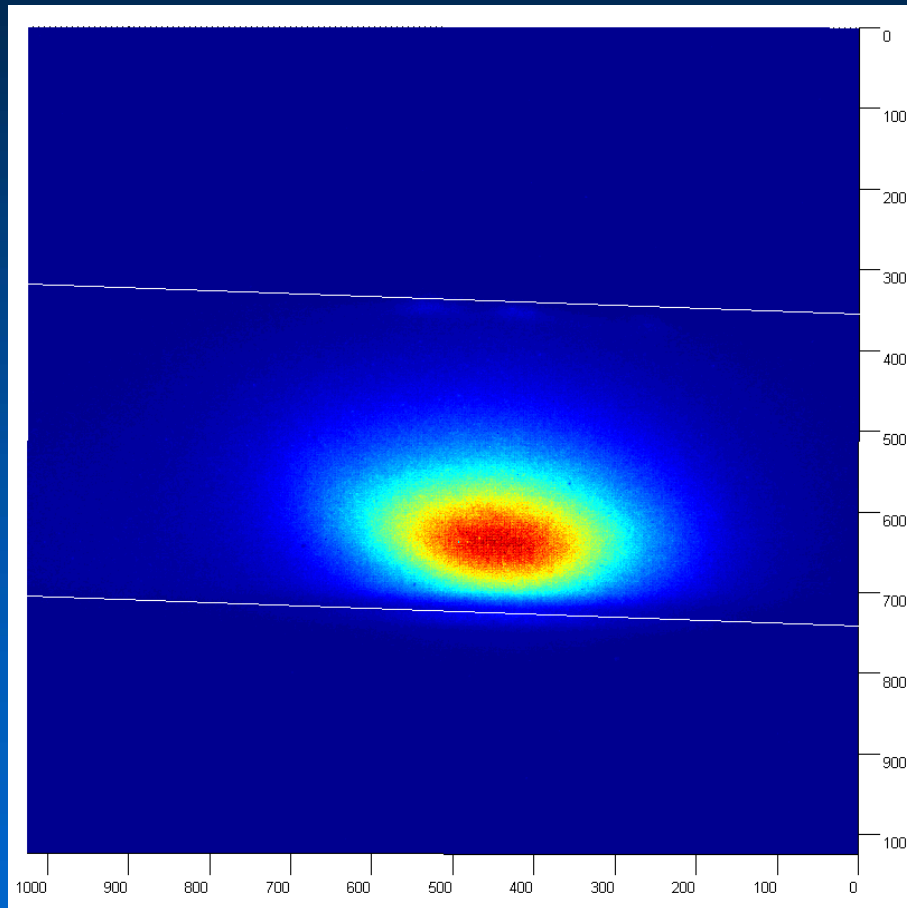
ENERGY BAND DIAGRAM



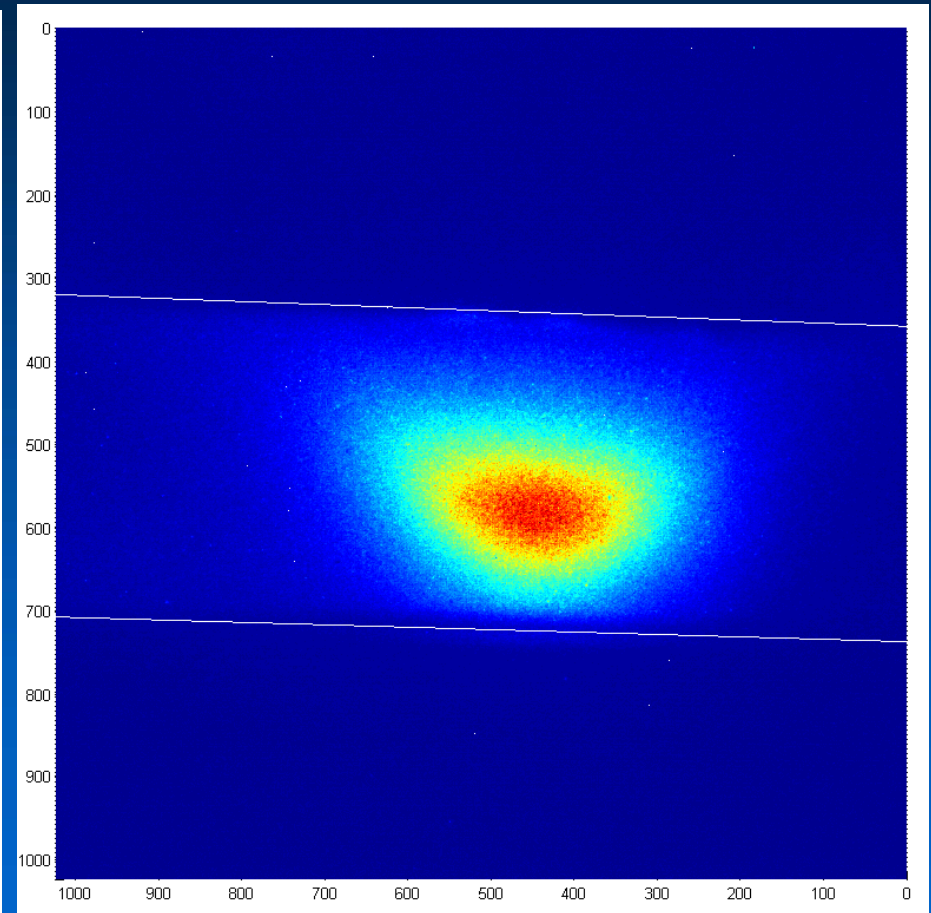
- Control of the Effective Secondary Electron Emission Coefficient



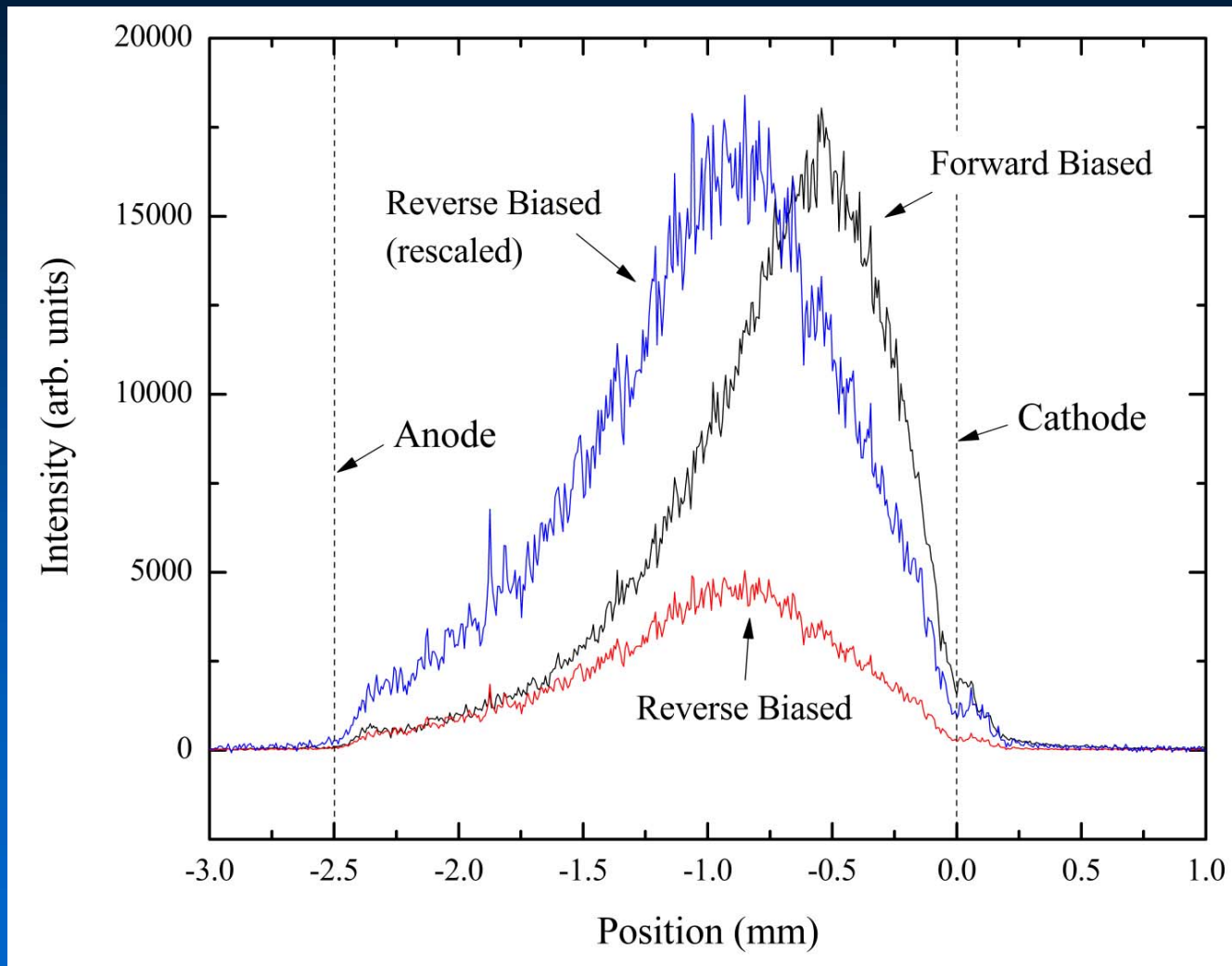
IMAGE OF COLLECTOR PLASMA



Forward Bias



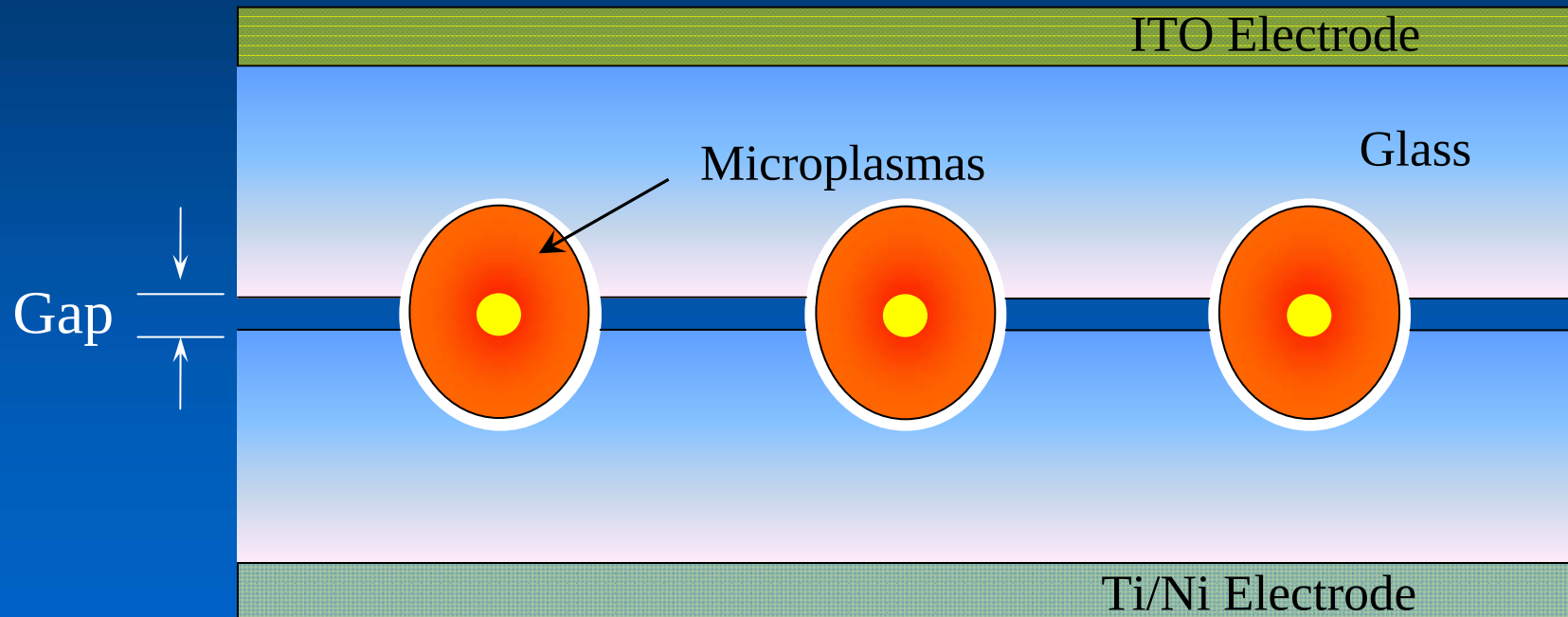
Reverse Bias

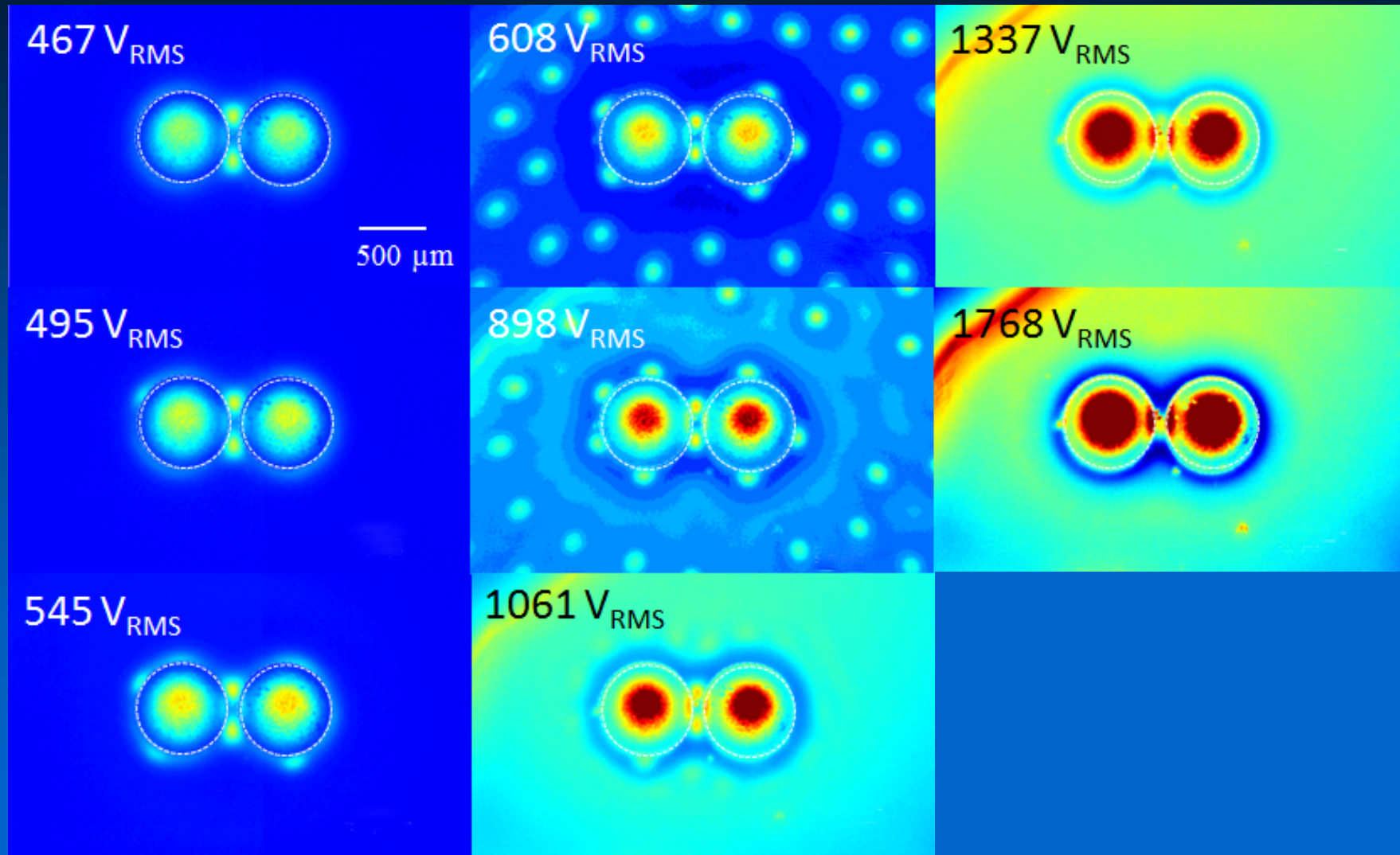






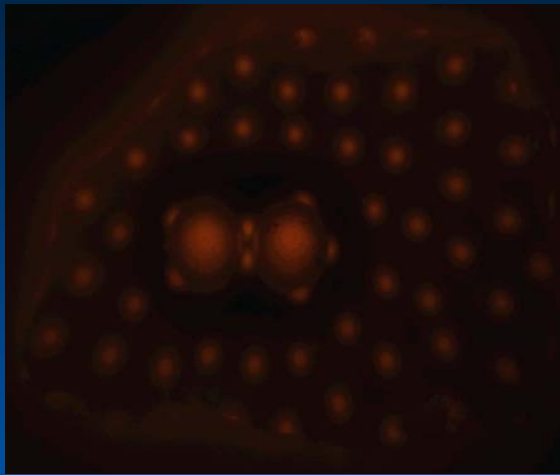
FREE-TO-BOUND PLASMA COUPLING



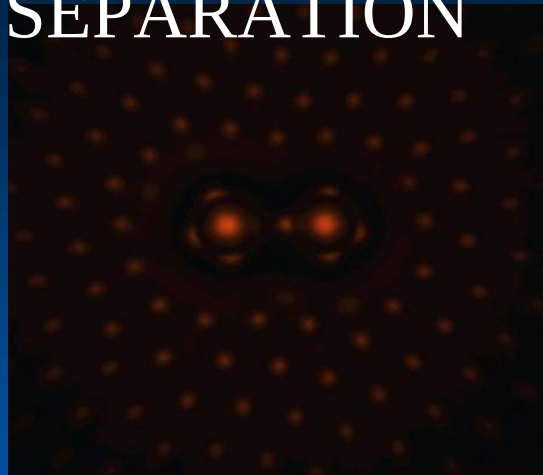




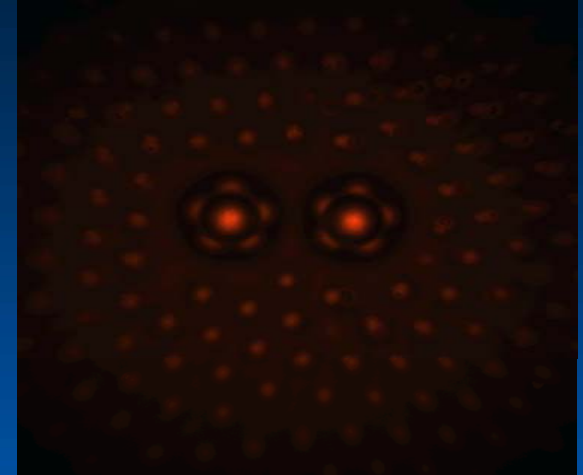
VARIATION OF BOUND PLASMA SEPARATION



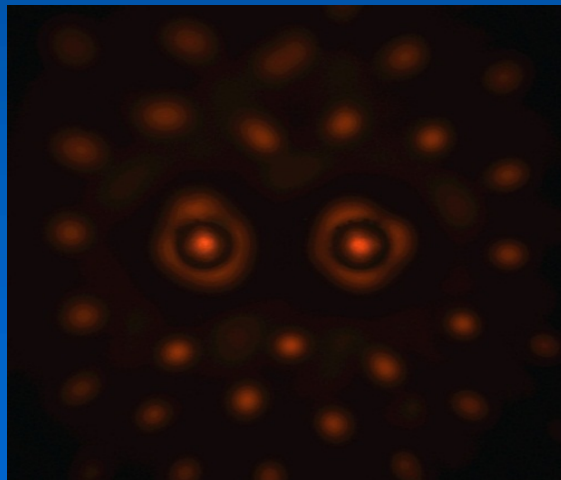
$80 \mu\text{m}$



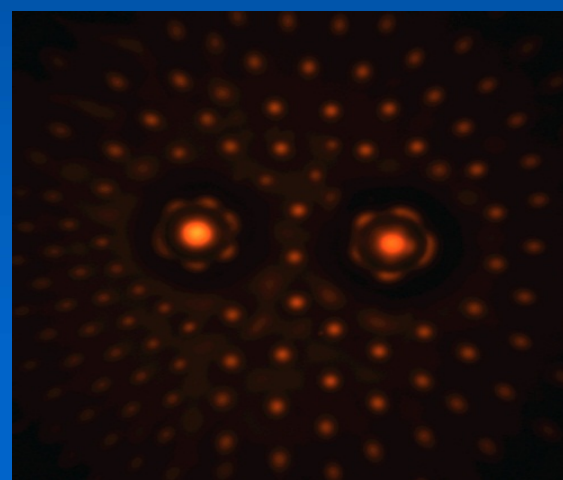
$400 \mu\text{m}$



$800 \mu\text{m}$



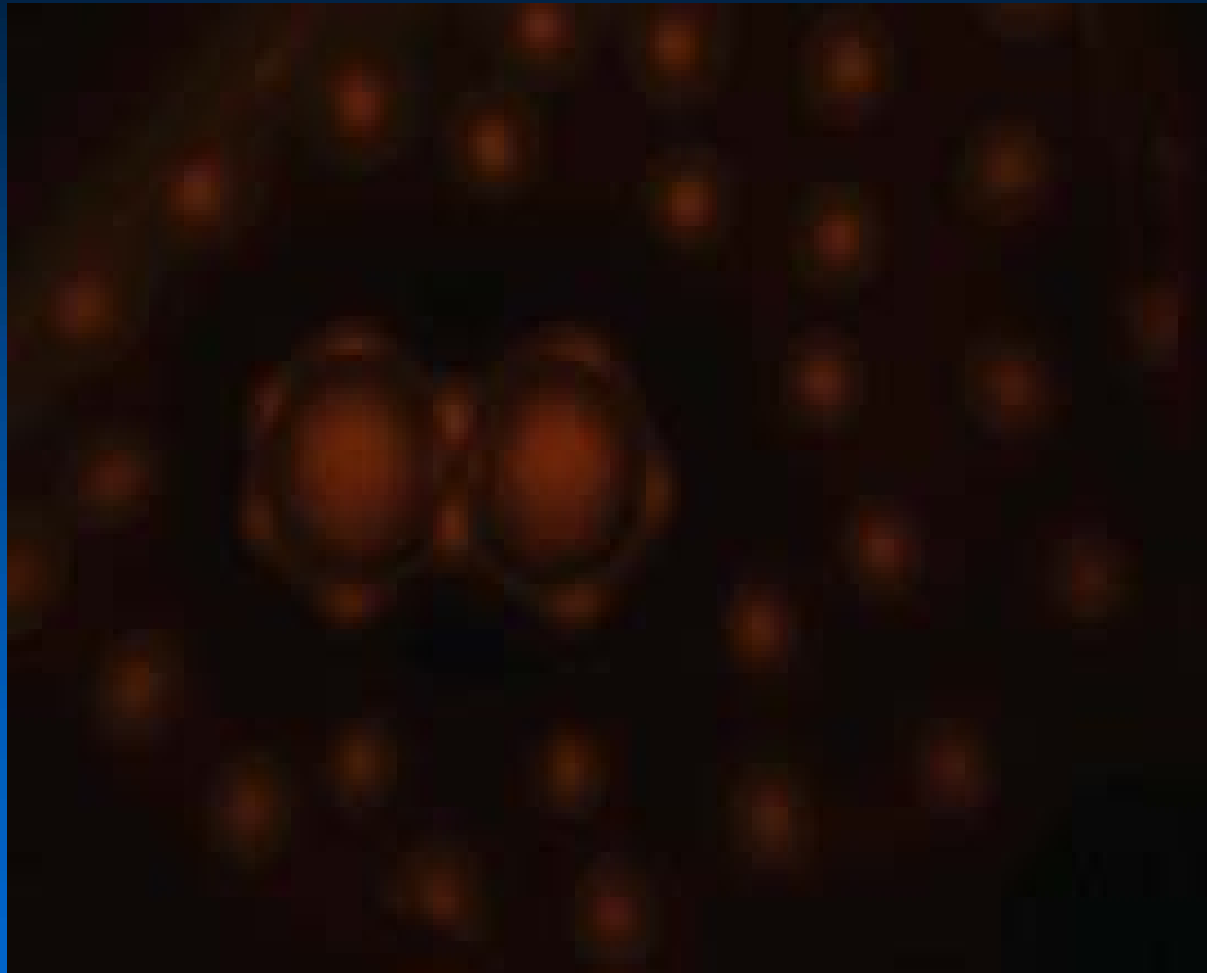
1.2 mm



1.6 mm



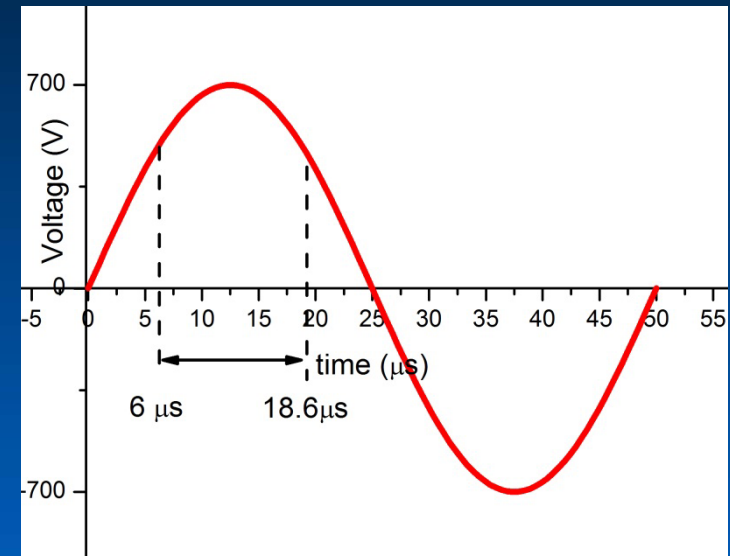
$d = 80 \mu\text{m}$



$P = 760 \text{ Torr Ne}$



TEMPORAL RESPONSE

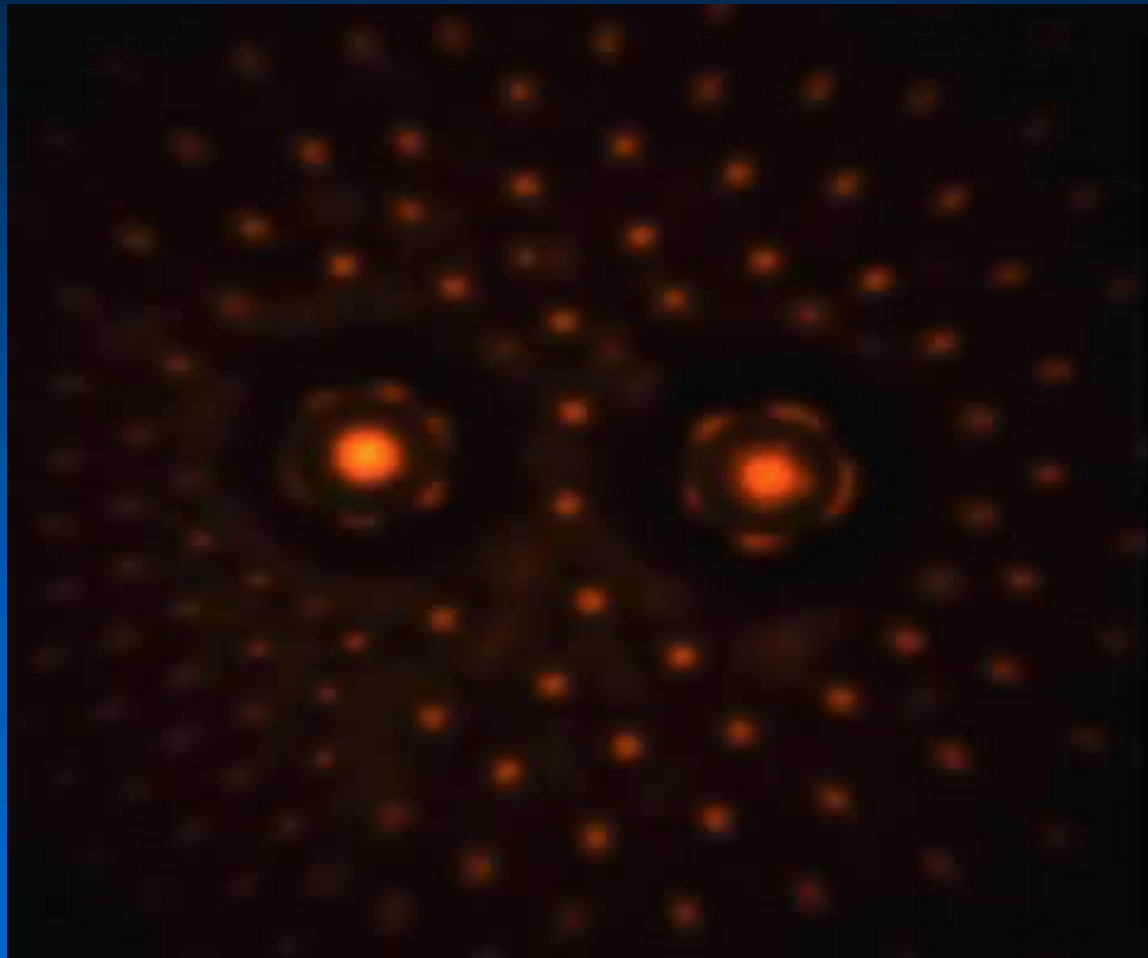


Exposure time: 200 ns

Time frame: 6 μs ~ 18.6 μs



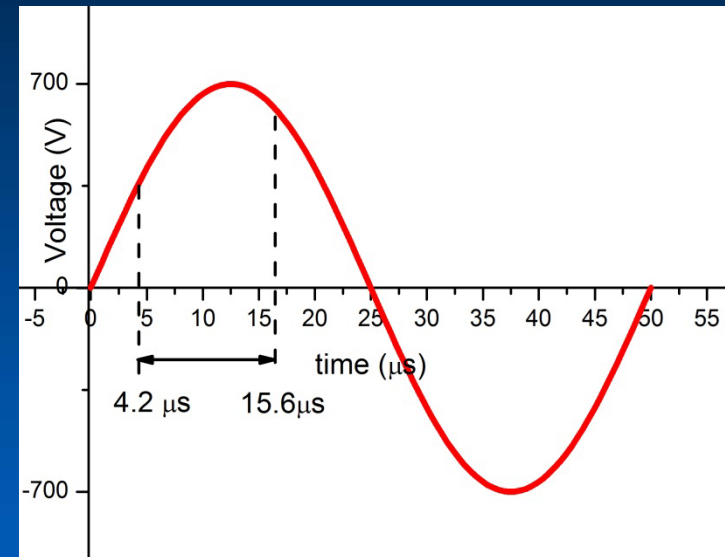
$d = 1.6 \text{ mm}$



$P_{\text{Ne}} = 760 \text{ Torr}$



TEMPORAL HISTORY

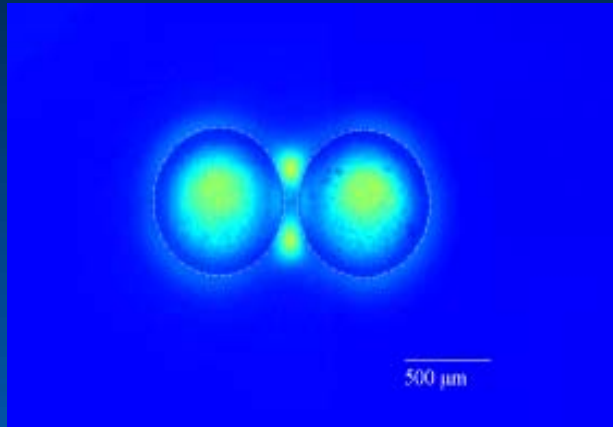


Exposure time: 200 ns
Time frame: 4.2 μs $\sim$ 15.6 μs



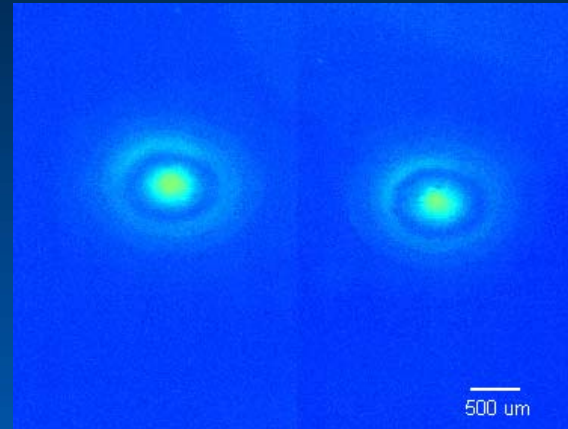
FALSE COLOR (TIME INTEGRATED)

80 μm device

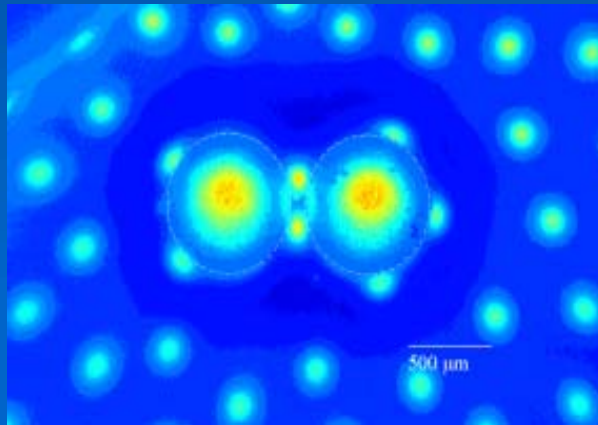


467 V_{RMS}

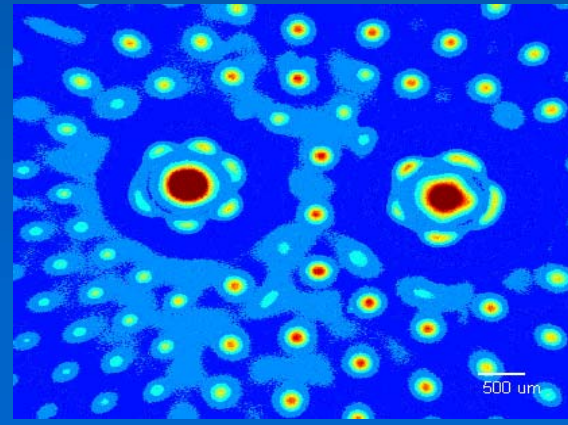
1.6 mm device



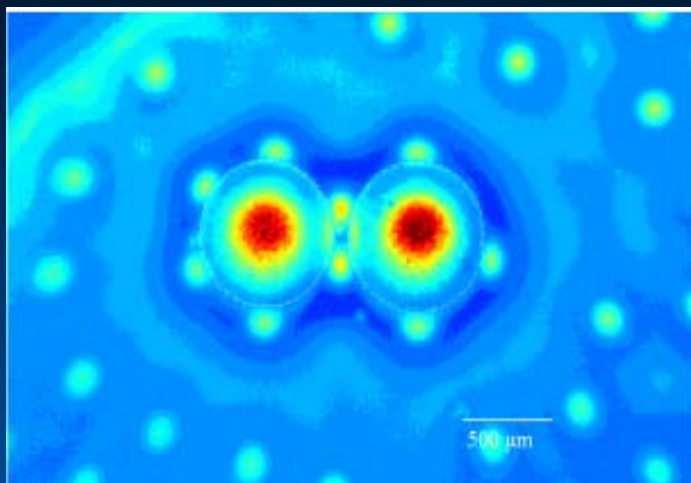
346 V_{RMS}



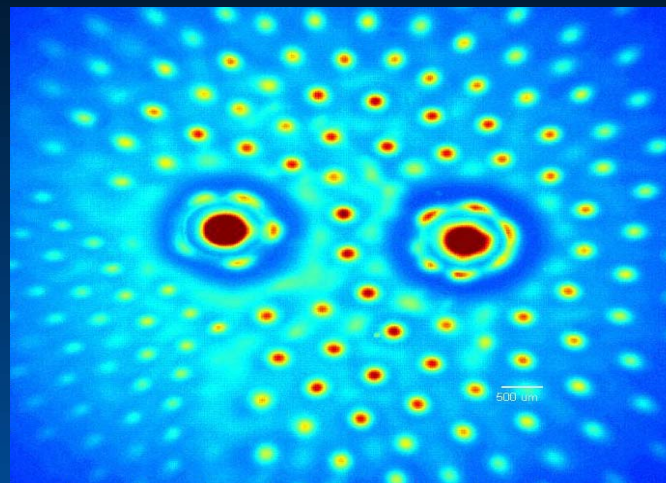
608 V_{RMS}



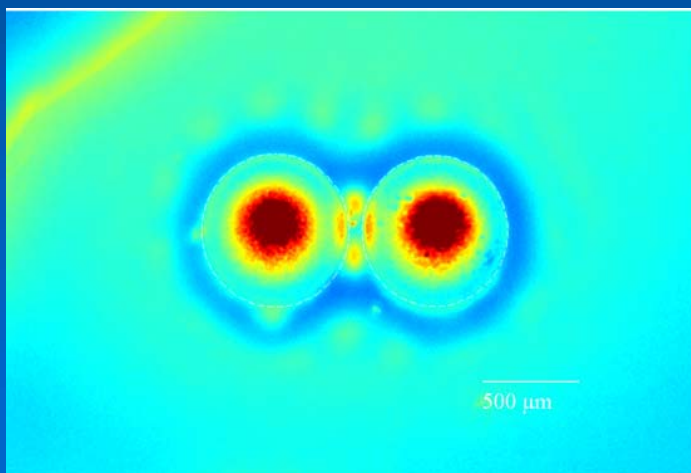
494 V_{RMS}



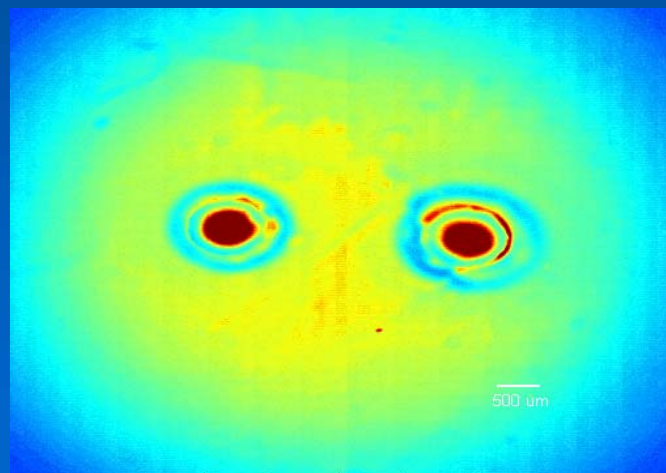
898 V_{RMS}



636 V_{RMS}



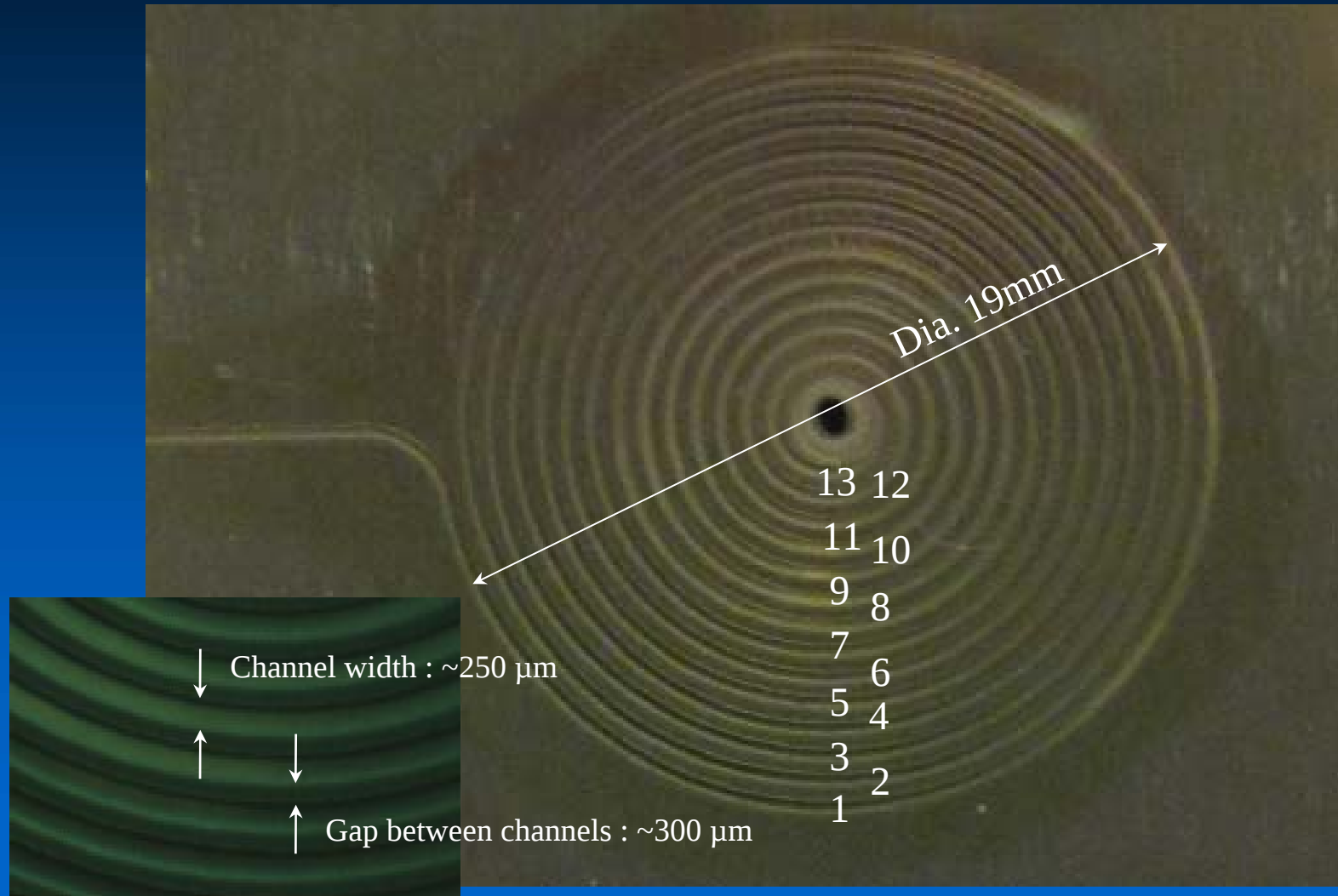
1061 V_{RMS}



1060 V_{RMS}



SINGLE MICROCHANNEL SPIRAL STRUCTURE





PLASMA PROPAGATION

$T_d = 0.6 \mu\text{s}$



$T_d = 0.74 \mu\text{s}$



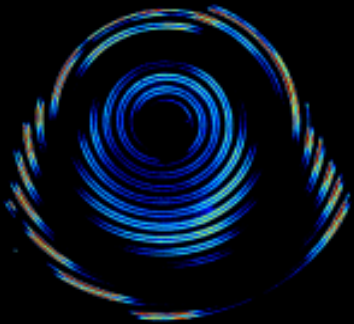
$T_d = 2.10 \mu\text{s}$



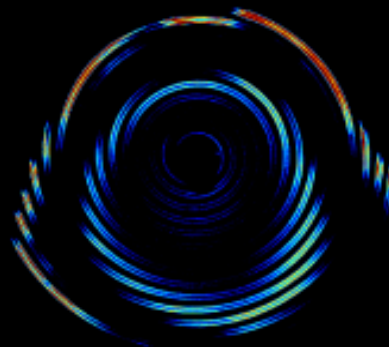
$T_d = 2.24 \mu\text{s}$



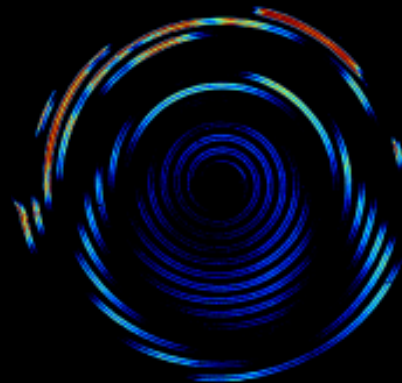
$T_d = 2.94 \mu\text{s}$



$T_d = 3.92 \mu\text{s}$



$T_d = 5.04 \mu\text{s}$



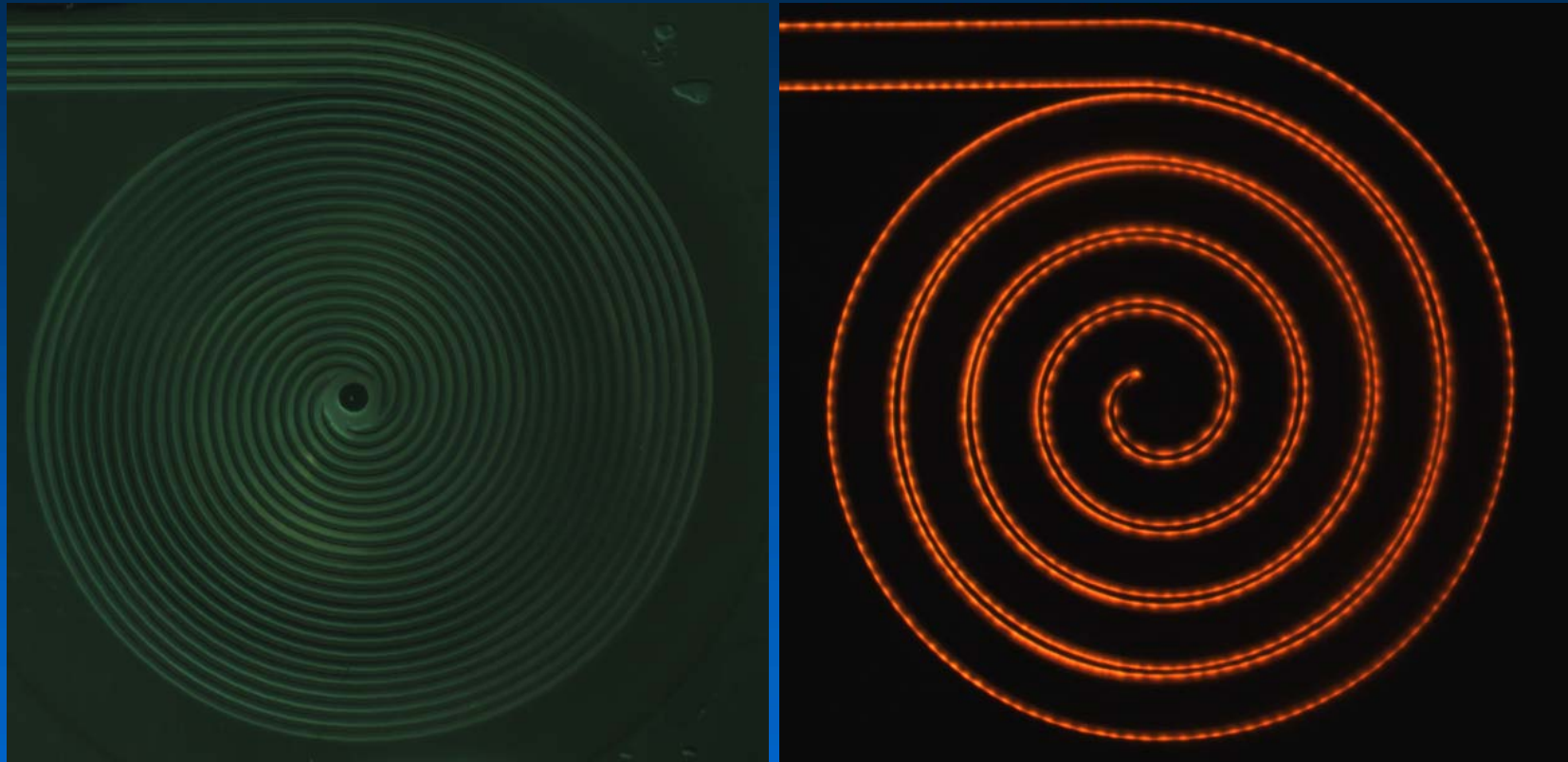
$T_d = 5.46 \mu\text{s}$



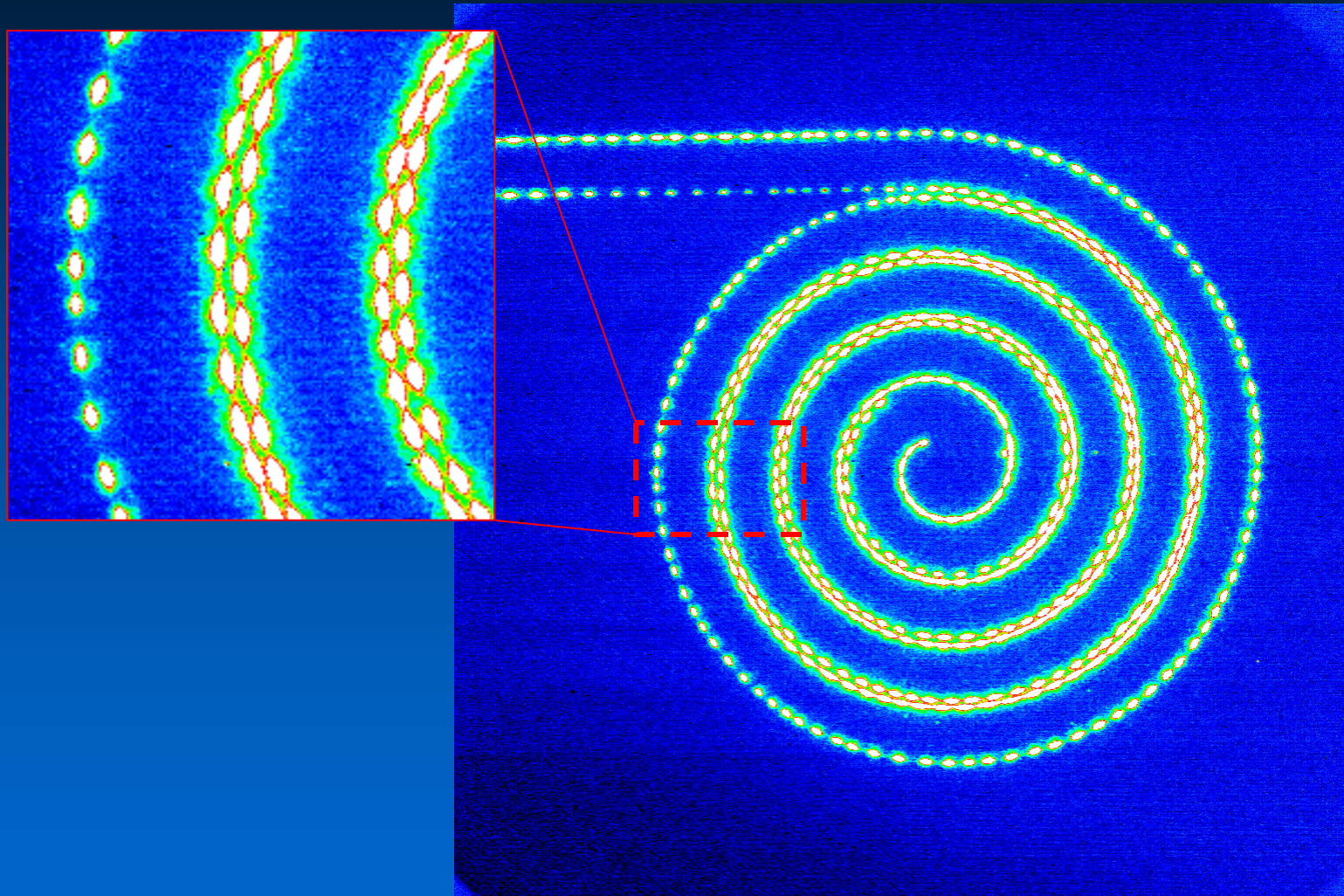
760 Torr Ar



5 CHANNELS SPIRAL DEVICE



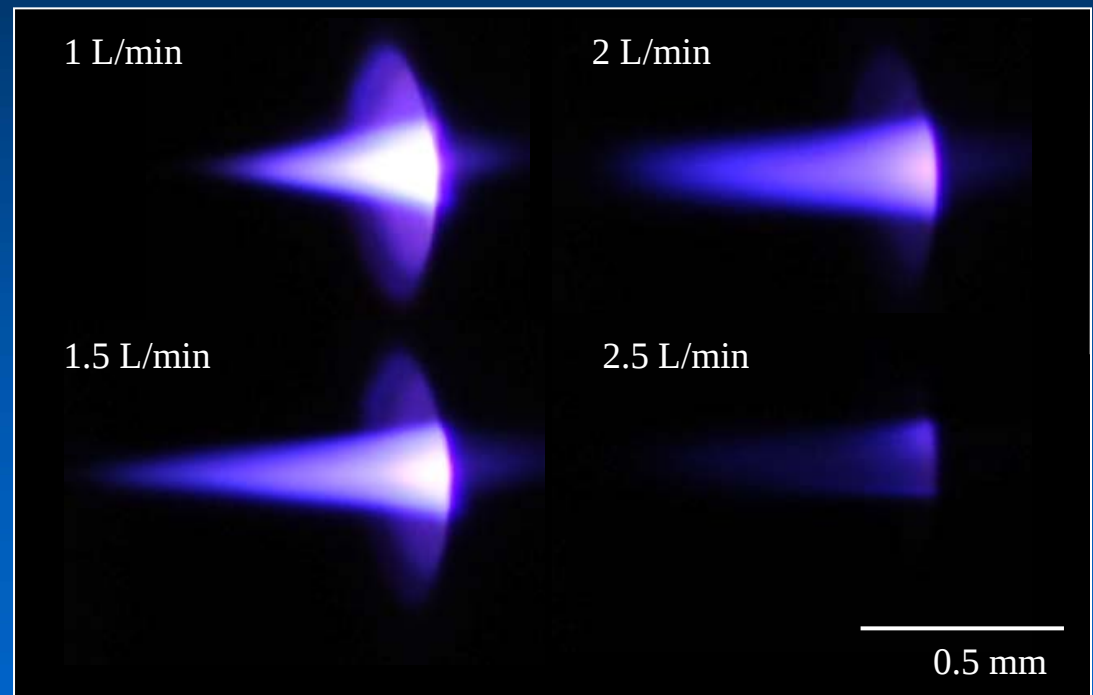
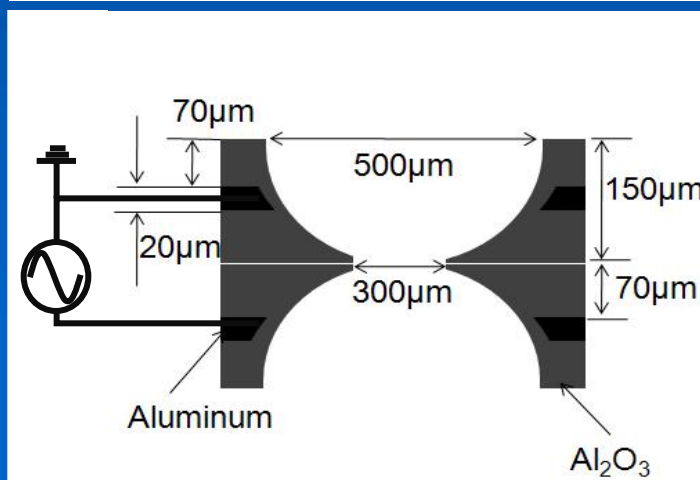
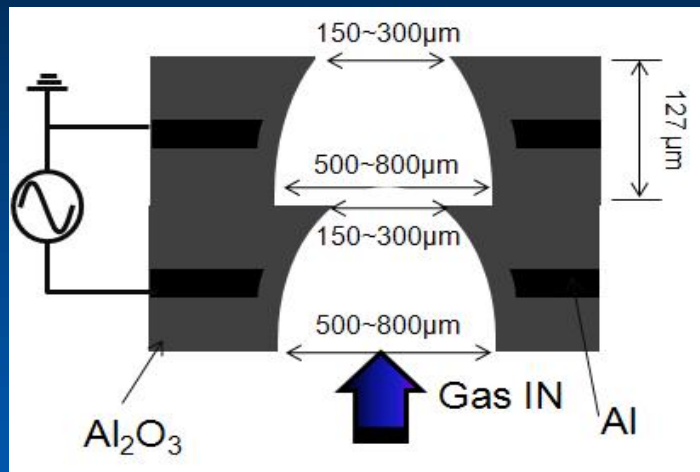
Ne 600 Torr



Exposure time: 50 ns

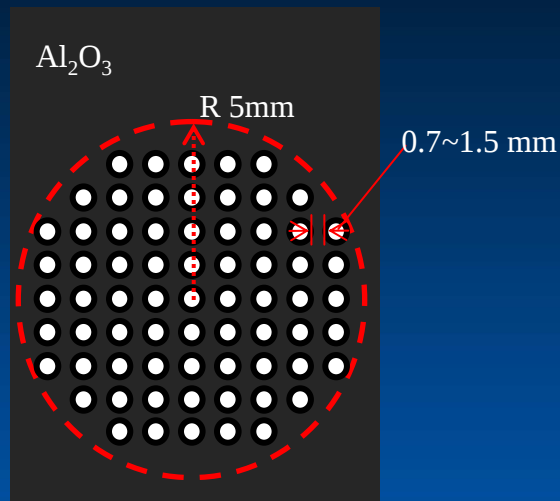


Al/Al₂O₃ MICROCAVITY PLASMA JET DEVICE

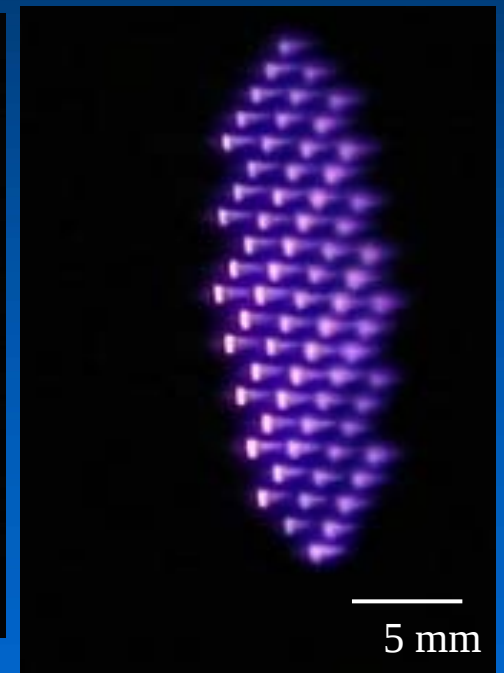
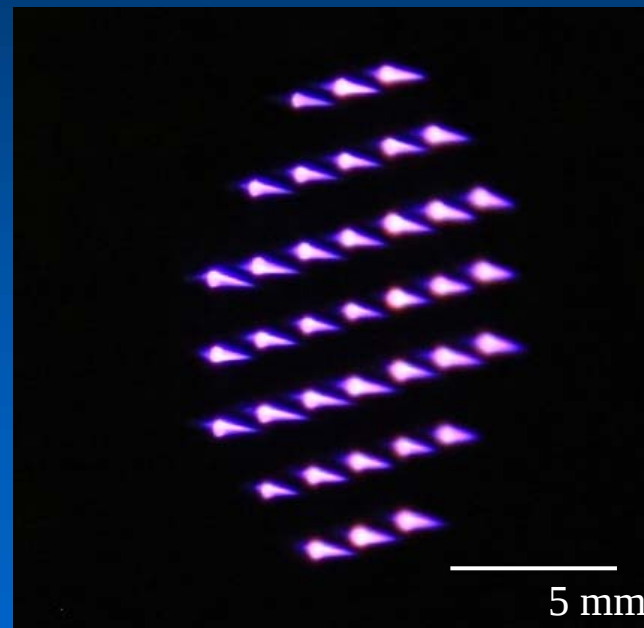
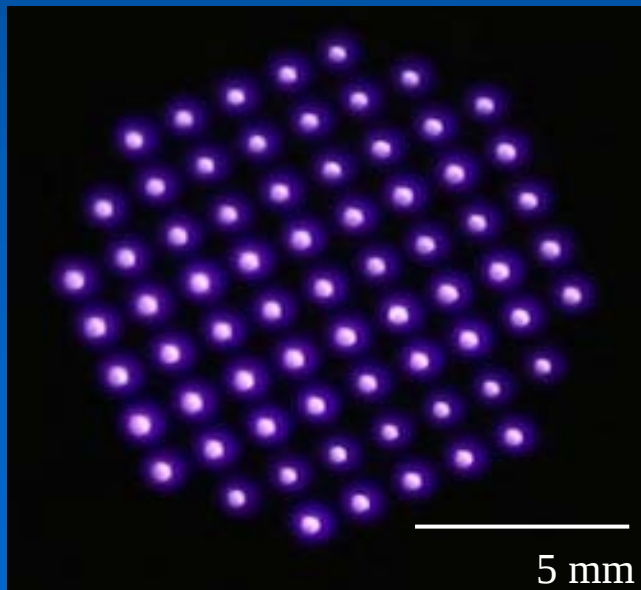




Al/Al₂O₃ MICROCAVITY JET ARRAY: PARALLEL OPERATION

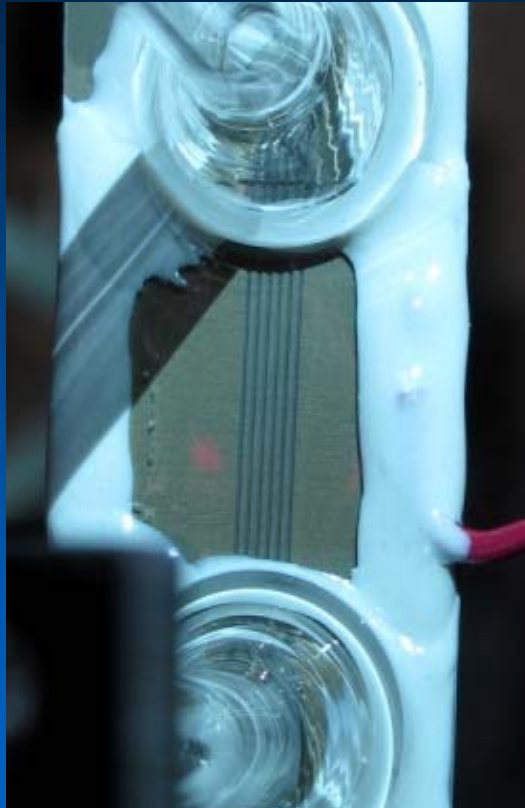


Up to 150 cavities

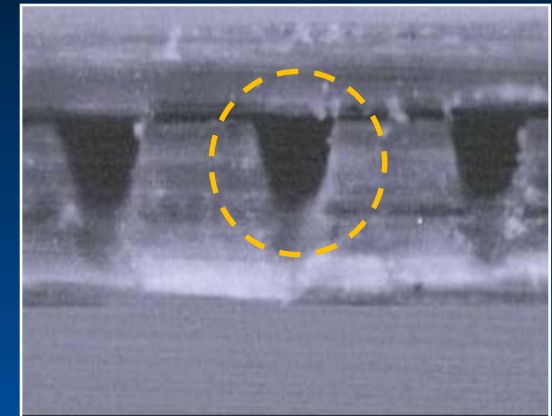
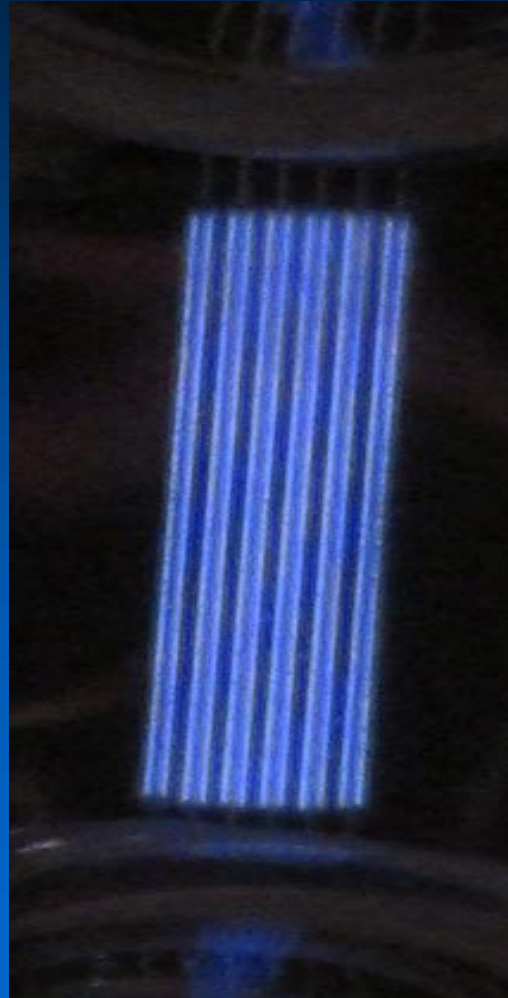




MICROPLASMA GENERATION OF OZONE



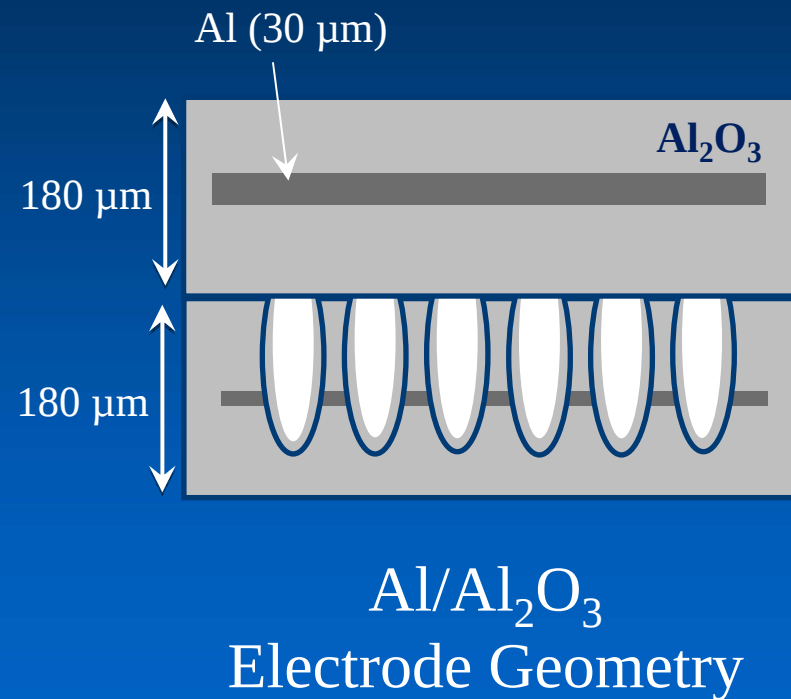
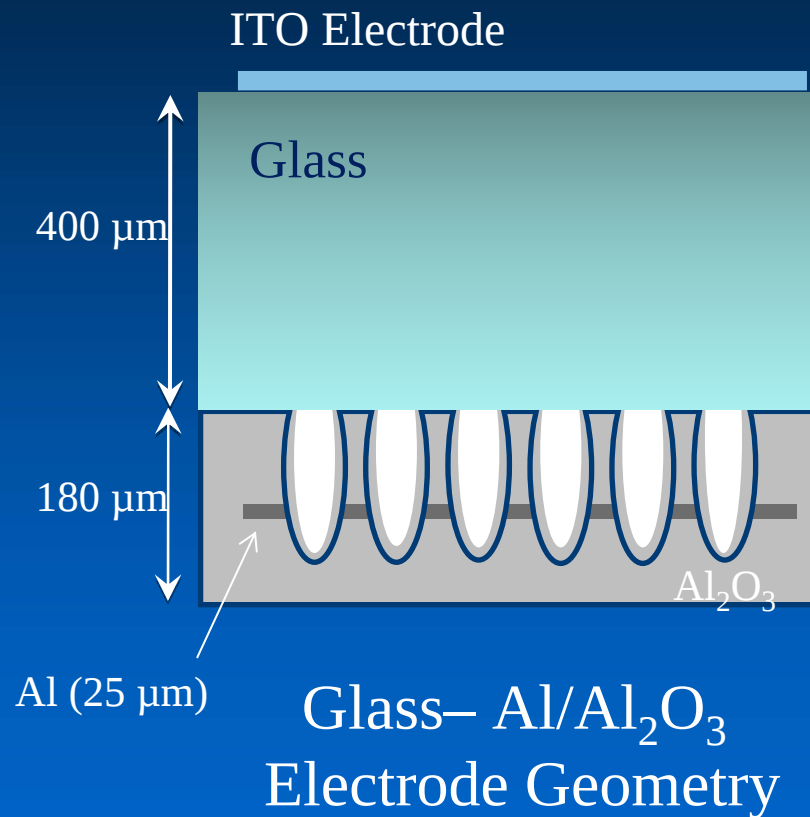
Channel Array Image



End On Image



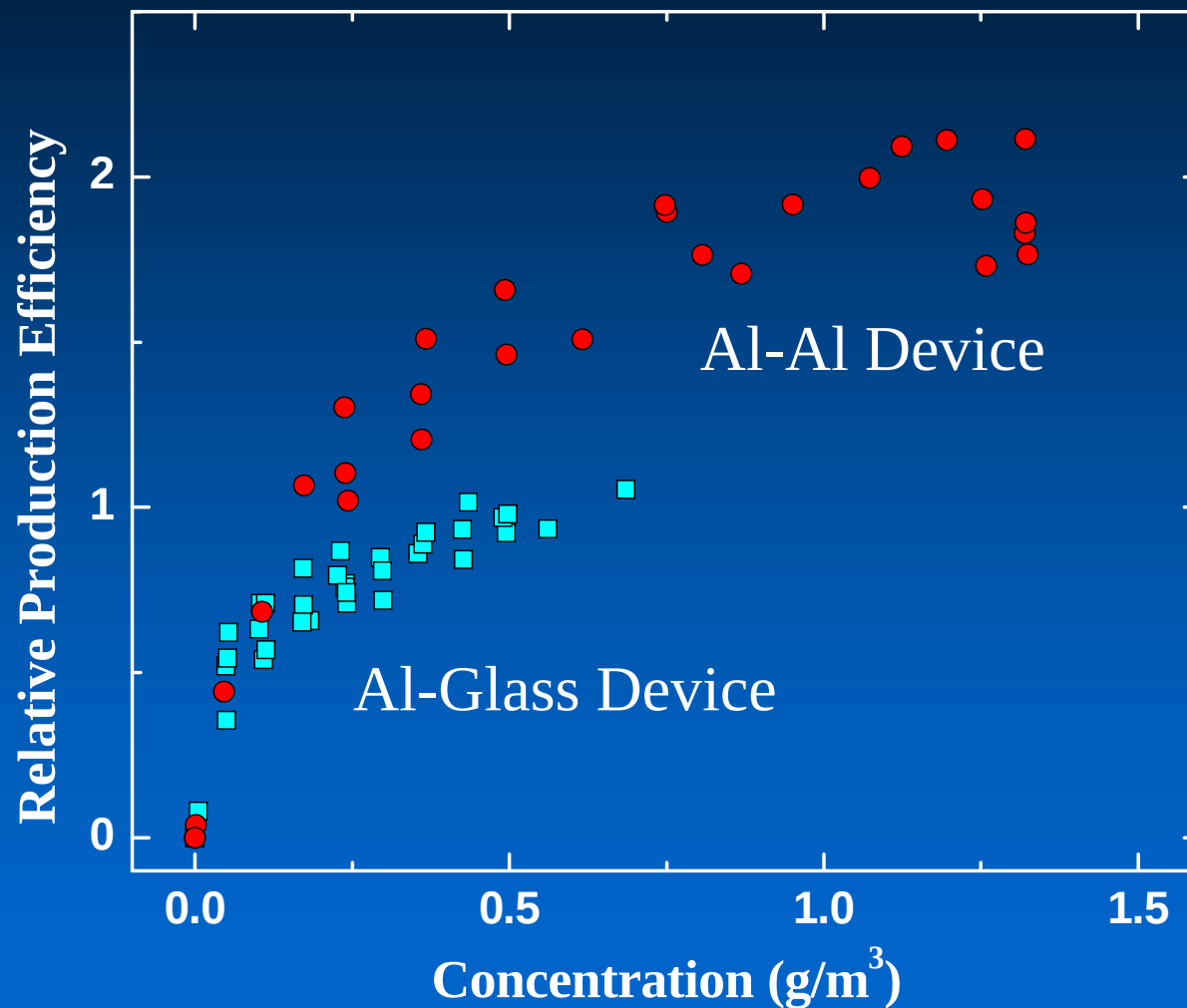
OZONE GENERATION IN TWO DIFFERENT DEVICE CONFIGURATIONS: 6 CHANNEL ARRAY



Microchannel Width: 220 μm , Depth: 130 μm
Channel Length : 22 mm



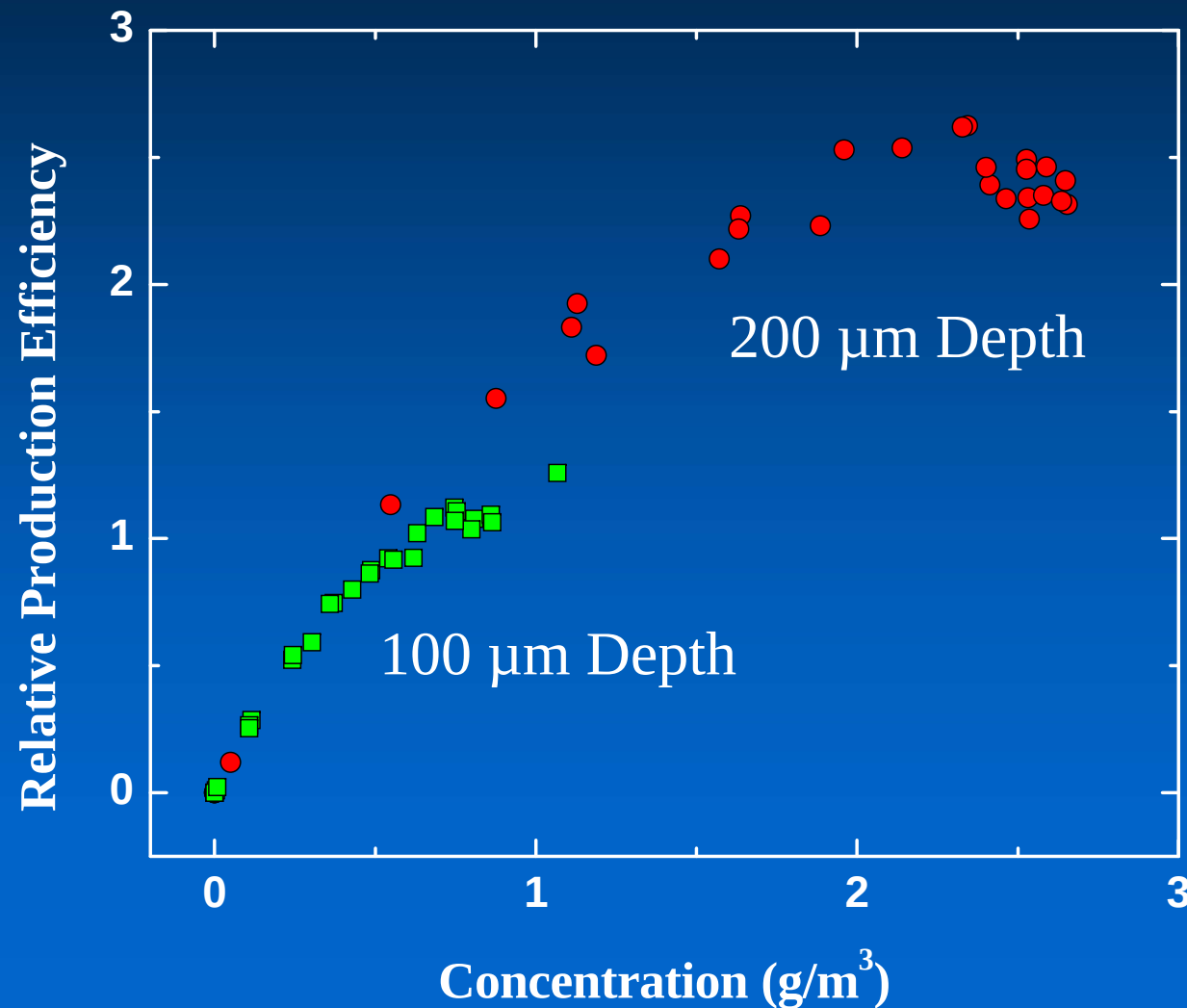
OZONE PRODUCTION EFFICIENCY



Doubled concentration and production efficiency in Al/Al₂O₃ electrode



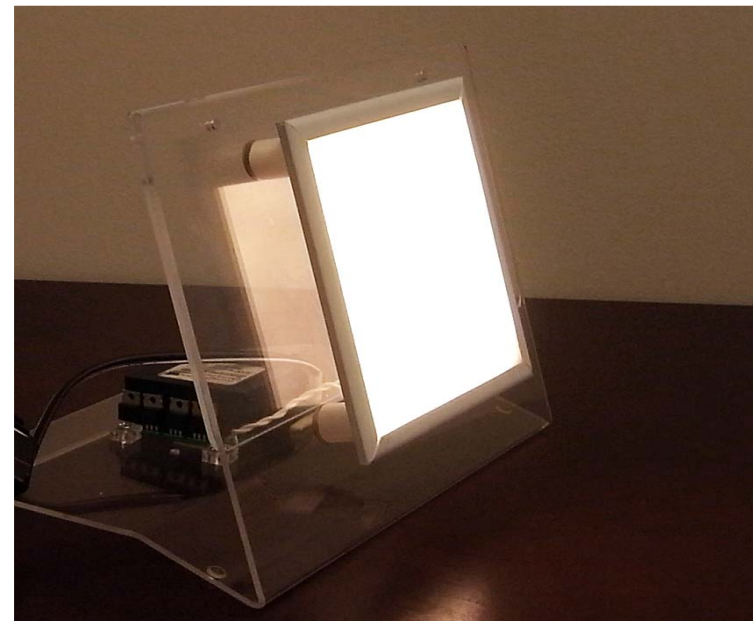
VARIATION IN CHANNEL DEPTH : 6 Channel Al-Al Device



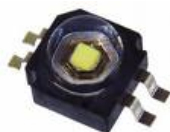
FLAT MICROPLASMA LAMP: Phoenix 6" × 6" (~ 225 cm²)



- Spatial Uniformity: $\pm 5 \%$
- Luminance : $>12,000 \text{ cd/m}^2$
- Efficacy: $> 25 \text{ lm/W}$
- CRI: > 80
- Fully Dimmable



LIGHTING TECHNOLOGY COMPETITION



Light Emitting Diode

LED

- Heat Sensitive => Heat Management
- “Dots” Forced into Planar Form
- Requires Robust Hardware
- Performance Tied to Cost (binning)
- Difficulty maintaining uniformity and intensity over time
- Requires waveguide technology limiting size and color spectrum
- Good color mixing is difficult to achieve in edge-lit structures



Organic Light Emitting Diode

OLED

- Short Lifetime
- High Manufacturing Cost => High Market Price
- Scale Limitation
- Low Light Output
- Efficacy Tied to Light Output



Microplasma

- High Light Output Natural Planar Source
- Cost / TCO Advantage
- Lightweight => Easy to Install
- Scalable => Design Flexibility
- Environmentally Friendly

	LED	OLED	Microplasma
Efficacy (lm/W)	54*	25-30**	25-35
Lifetime (hrs)	50,000	2000-14,000	50,000
\$ per lm/W	\$2.00 ****	\$10.0 (\$300 @ 30 lm/W)	\$1.00 *** (\$25 @ 25lm/W)
\$ per klm	~ \$100	\$ 6000 - \$25000	\$ 42 (\$25 @ 600 lm)
\$ per m ²	\$ 800 - 900	\$17, 000 – 75,000	\$ 200 – 250 (expected)

* lm/W based on initial lumens in average luminaire (per DOE CALiPER Summary Report, October 2010)

** OLED WORKS LLC, April 2011

*** at present – January 2011 - \$ per lm/W will further decrease with improved efficacy because cost base stays (relatively) the same

**** \$ per lm/W calculated using multiple LED units as necessary to create equivalent 6” uniform distribution planar light emission



CONCLUSIONS

- Hybrid plasma/semiconductor devices provide the potential for manipulating microscopic processes at the plasma-solid interface
- Control of secondary electron emission coefficient
- Nonequilibrium plasmas can be modulated and extinguished with $\lesssim 1$ V across base-emitter junction
- Bound-free plasma interactions have been observed and can be controlled (plasma gates and traps)
- Plasma chemical generation of ozone efficiency approaches best industrial values
- Flat plasma lamps outperform OLEDs in cost and performance